TEST REPORT

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1	Test Report No		002650		
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4	Use of Report		For SABS COC application.		
5	Kind of Product		ITE /ICT POWER SUPPLY		
6	Model Name		GTM91099-6024-T3A		
7	Variant Model		GTM91099-6015-3.0-T3A, GTM91099-3009-4.0-T3A, GTM91099-6024-8.0-T2		
8	Sample Receipt Date		Aug. 27, 2021		
9	Issuance Date		Feb. 28, 2022		
10	Test Period		Sep. 01, 2021 ~ Dec. 23, 2021		
11	Test Standard(method) used		**SANS 2332:2017** **SANS 61000-3-2:2009** **SANS 61000-3-3:2009** **SANS 2335:2018**		
12	Test Results		**Pass**		

The results shown in this test report refer only to the sample(s) tested unless otherwise stated.
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Conformation	Reviewed by Pike Lee EMC Test Engineer	Approved by Andy Chiu Authorized Signatory

REPORT REVISION HISTORY

Date	Revision	Page No
Feb. 24, 2022	Issued (1)	All
Feb. 28, 2022	Deleted the relevant information of GTM91099-6048-T3A Model.	All

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TABLE OF CONTENTS

REPORT REVISION HISTORY **2**

1.0 General Product Description **5**
1.1 Model Differences 6
1.2 Device Modifications 6
1.3 Difference Table between Basic Model and Variant Models 6
1.4 EUT Configuration(s) 6
1.5 Test Software 7
1.6 EUT Operating Mode(s) 7
1.7 Configuration 7
1.8 Calibration Details of Equipment Used for Measurement 8
1.9 Test Facility 8
1.10 Laboratory Accreditations and Listings 8
1.11 Measurement Uncertainty 8

2.0 EMC Test Regulations/Standards **10**
2.1 Emission and Immunity Test Regulations/Standards 10
2.2 Purpose of Test 10
2.3 Name and Address of the Laboratory 10
2.4 Summary of Test Results 11

3.0 Results of Individual Test **13**
3.1 Radiated Disturbance (Up to 1 GHz) 13
3.2 Conducted emissions AC mains power port 18
3.3 Harmonic current emissions 23
3.4 Voltage changes, voltage fluctuations and flicker 24
3.5 Immunity Performance Criteria and Requirements 26
3.6 Electrostatic discharge immunity 30
3.7 Radiated, radio-frequency, electromagnetic field immunity 34
3.8 Electrical fast transient/burst immunity 37
3.9 Surge immunity 39
3.10 Immunity to conducted disturbances, induced by radio-frequency fields 42
3.11 Power frequency magnetic field immunity 45
3.12 Voltage dips, short interruptions and voltage variations immunity 47

4.0 APPENDIX A - Test Setup Photos and Configuration **49**
4.1 Radiated disturbance (Up to 1 GHz) 50
4.2 Conducted emissions AC mains power port 51
4.3 Voltage changes, voltage fluctuations and flicker 52
4.4 Electrostatic discharge immunity 52
4.5 Radiated, radio-frequency, electromagnetic field immunity 53

4.6 Electrical fast transient/burst immunity 53
4.7 Surge immunity 54
4.8 Immunity to conducted disturbances, induced by radio-frequency fields 54
4.9 Power frequency magnetic field immunity 55
4.10 Voltage dips, short interruptions and voltage variations immunity 55

5.0 APPENDIX B – EUT Photographs 56
5.1 EUT External Photographs 57
5.2 EUT Internal Photographs 65
5.3 PCB 74
5.4 Label and Location 75

6.0 APPENDIX C – Critical Component List 76

1.0 General Product Description

1.0.1 Product Specification

No.	ITEM	APPLICATION
1	Test Sample	ITE /ICT POWER SUPPLY
2	Model	GTM91099-6024-T3A
3	Variant Model/Type No.	GTM91099-6015-3.0-T3A, GTM91099-3009-4.0-T3A, GTM91099-6024-8.0-T2
4	Model Difference	The output voltage, power and current are different.
5	Test Sample Serial Number	N/A
6	Dimensions (L x H x D)	120 mm x 52 mm x 33 mm
7	Maximum Clock Frequency	60Hz
8	Test Sample	Engineering Sample No.: SH2021082723, SH2021082723-1, SH2021082723-2, SH2021082723-3

1.0.2 Electrical Ratings

1. GTM91099-6024-T3A	INPUT:	100-240V~, 50-60Hz 1.5A	OUTPUT:	24V⎓2.5A
2. GTM91099-6024-8.0-T2	INPUT:	100-240V~, 50-60Hz 1.5A	OUTPUT:	16V⎓3.75A
3. GTM91099-6015-3.0-T3A	INPUT:	100-240V~, 50-60Hz 1.5A	OUTPUT:	12V⎓5.0A
4. GTM91099-3009-4.0-T3A	INPUT:	100-240V~, 50-60Hz 1.5A	OUTPUT:	5V⎓6.0A

1.0.3 Test Voltage & Frequency

Unless indicated otherwise on the individual data sheet or test results, the test voltage and frequency was as indicated below.

Power supply voltage

- ■ 230V/50 Hz / 1ϕ
- □ 400V/50 Hz 3PE
- □ 12 V DC
- □ 220V/50 Hz / 1ϕ
- □ 115V/60Hz / 1ϕ
- □ 400V/50 Hz 3NPE
- □ 24 V DC

1.1 Model Differences

The output voltage, power and current are different.

1.2 Device Modifications

Not applicable

1.3 Difference Table between Basic Model and Variant Models

Not applicable

1.4 EUT Configuration(s)

See Appendix A for individual test set-up configuration(s). The following peripheral devices and/or interface cables were connected during the measurement:

☒ Peripheral Devices

Device	Model No.	Serial No.	Manufacturer
LOAD	N/A	N/A	N/A

☒ Cable Description

No.	From		To		Type of Cable		
	Device	I/O Port	Device	I/O Port	Length (m)	Shielded or Unshielded	Ferrite Core [Y/N]
1	Adapter	AC IN	AC mains	N/A	1.8	U	N
2	EUT	DC	LOAD	DC	1.5	U	N

NOTE:
(1) Shielded or Unshielded: Unshielded=U, Shielded=S

1.5 Test Software

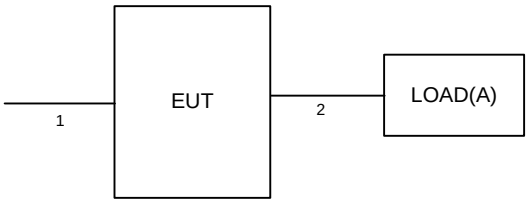
N/A

1.6 EUT Operating Mode(s)

Equipment under test was operated during the measurement under the following conditions:

Operating Mode	Function	Test Item
1	FULL LOAD(Adapter: GTM91099-6024-8.0-T2)	Pretest
2	FULL LOAD(Adapter: GTM91099-6015-3.0-T3A)	Pretest
3	FULL LOAD(Adapter: GTM91099-3009-4.0-T3A)	Article 3.1, 3.2, 3.3, 3.4, 3.5, 3.6, 3.7, 3.8, 3.9, 3.10, 3.11, 3.12

1.7 Configuration



Ground plane

Remote System

■ Ferrite Core

1.8 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable, therefore, all test data recorded in this report is traceable.

1.9 Test Facility

The measurement facility is BTL Inc.

The sites are constructed in conformance with the requirements of **CISPR 16-1-4**.

1.10 Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Registration Number	Logo
Taiwan	Taiwan Accreditation Forum (TAF)	**CISPR 32, CISPR 35, IEC 61000-3-2, IEC 61000-3-3, IEC 61000-4-2, IEC 61000-4-3, IEC 61000-4-4, IEC 61000-4-5, IEC 61000-4-6, IEC 61000-4-8, IEC 61000-4-11**	0659	ilac-MRA TAF Testing Laboratory 0659

1.11 Measurement Uncertainty

The reported uncertainty of measurement **y ± U**, where expanded uncertainty U is based on a standard uncertainty multiplied by a coverage factor of **k=2**, providing a level of confidence of approximately 95%.
The measurement instrumentation uncertainty considerations contained in **CISPR 16-4-2**.
The BTL measurement uncertainty is less than the **CISPR 16-4-2** U_{CISPR} requirement.

1.11.1 Radiated disturbance (Up to 1 GHz)

Test Site	Method	Measurement Frequency Range	Ant. H / V	U,(dB)
CB11 (3m)	**CISPR 16-4-2**	30MHz ~ 200MHz	V	4.26
		30MHz ~ 200MHz	H	3.76
		200MHz ~ 1,000MHz	V	4.46
		200MHz ~ 1,000MHz	H	3.84

1.11.2 Conducted emissions AC mains power port

Test Site	Method	Measurement Frequency Range	U,(dB)
C05	**CISPR 16-4-2**	150 kHz ~ 30MHz	3.44

1.11.3 Voltage changes, voltage fluctuations and flicker

Test Site	Method	Test Item	U(%)
SR09	**IEC 61000-3-2 IEC 61000-3-3**	Voltage	1.28
		Current	0.42

1.11.4 Immunity

Test Site	Method	Test Item	U
SR02	**EN 61000-4-2**	Rise time	≤12.5 %
		Peak Current	≤6.0 %
		Current at 30ns	≤6.0 %
		Current at 60ns	≤6.0 %
CB17	**EN 61000-4-3**	General test 80MHz~1GHz 1GHz~6GHz	 2.10 dB 2.26 dB
SR01	**EN 61000-4-4**	voltage peak value(VP)	4.58 %
		voltage rise time (tr)	14.00 %
		voltage pulse width(pw)	11.40 %
		Pulse Freq.(kHz)	0.00 %
		Burst Duration(ms)	1.33 %
		Burst Period(ms)	0.07 %
		voltage peak value(VP)-with clamp(RJ-45)	12.04 %
		voltage rise time (tr) -with clamp(RJ-45)	2.00 %
		voltage pulse width(tw) -with clamp(RJ-45)	13.00 %
SR01	**EN 61000-4-5**	voltage peak value(VP)	8.99 %
		voltage rise time (Tfv)	13.25 %
		voltage duration time(td)	10.20 %
SR09	**EN 61000-4-6**	CDN M3 test process(3 power lines)	1.34 dB
		CDN M2 test process(2 power lines)	1.34 dB
SR01	**EN 61000-4-8**	PFMF mG Calibration	9.30 %
SR01	**EN IEC 61000-4-11**	DIP Amplitude	1.55 %
		DIP Time Event	1.00 %
		DIP Phase	1.22 %

Note: Unless specifically mentioned, the uncertainty of measurement has not been taken into account to declare the compliance or non-compliance to the specification.
Our calculated Measurement Instrumentation Uncertainty is shown in the tables above. These are our U_{lab} values in **CISPR 16-4-2** terminology.
Since Table 1 of **CISPR 16-4-2** has values of measurement instrumentation uncertainty, called U_{CISPR}, as follows:
Conducted Disturbance (mains port) – 150 kHz – 30 MHz: 3.6 dB
Radiated Disturbance (electric field strength on an open area test site or alternative test site) – 30 MHz – 1000 MHz: 5.2 dB
It can be seen that our U_{lab} values are smaller than U_{CISPR}.

2.0 EMC Test Regulations/Standards

The tests were performed according to following regulations:

EMC – SANS 2332:2017
EMC – SANS 61000-3-2:2009
EMC – SANS 61000-3-3:2009
EMC – SANS 2335:2018

2.1 Emission and Immunity Test Regulations/Standards

Electromagnetic compatibility of multimedia equipment — Emission requirements

Electromagnetic compatibility (EMC)

Part 3-2: Limits — Limits for harmonic current emissions (equipment input current ≤ 16 A per phase)

Electromagnetic compatibility (EMC)

Part 3-3: Limits — Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤16 A per phase and not subject to conditional connection

Information technology equipment — Immunity characteristics — Limits and methods of measurement

2.2 Purpose of Test

To determine whether the equipment under test fulfils the EMC emission and immunity requirements of the standards.

2.3 Name and Address of the Laboratory

Name: BTL Inc.
Address: No. 68-1, Ln. 169, Sec. 2, Datong Rd., Xizhi Dist., New Taipei City 221, Taiwan (R.O.C.)

2.4 Summary of Test Results

Applied standard	Title		Applied	Test Result
SANS 2332:2017	Radiated emissions up to 1 GHz		YES	**Pass**
	Radiated emissions above 1 GHz		NO	**N/A** **NOTE (2)**
	Radiated emissions from FM receivers		NO	**N/A** **NOTE (1)**
	Conducted emissions AC mains power port		YES	**Pass**
	Asymmetric mode conducted emissions	AAN	NO	**N/A** **NOTE (1)**
		Current Probe	NO	**N/A** **NOTE (1)**
		CVP	NO	**N/A** **NOTE (1)**
	Conducted differential voltage emissions		NO	**N/A** **NOTE (1)**

NOTE: (1) ”N/A” denotes test is not applicable in this Test Report.
(2) The EUT’s max operating frequency exceeds 108 MHz, so the test will be performed.

Applied standard	Title	Applied	Test Result
SANS 61000-3-2:2009	Harmonic current emissions	NO	**N/A** **NOTE (3)**
SANS 61000-3-3:2009	Voltage changes, voltage fluctuations and flicker	YES	**Pass**

NOTE: (1) ”N/A” denotes test is not applicable in this Test Report.
(2) The maximum clock frequency of the equipment is 60Hz, less than 108MHz, so the radiated emissions above 1 GHz does not need to be tested.
(3) For equipment with a rated power of 75 W or less, limits are not specified.

Applied standard	Title	Applied	Test Result
SANS 2335:2018	Electrostatic discharge immunity	YES	**Pass**
	Radiated, radio-frequency, electromagnetic field immunity	YES	**Pass**
	Electrical fast transient/burst immunity	YES	**Pass**
	Surge immunity	YES	**Pass**
	Immunity to conducted disturbances, induced by radio-frequency fields	YES	**Pass**
	Power frequency magnetic field immunity	YES	**Pass**
	Voltage dips, short interruptions and voltage variations immunity	YES	**Pass**

NOTE: (1) ”N/A” denotes test is not applicable in this Test Report.

3.0 Results of Individual Test

3.1 Radiated Disturbance (Up to 1 GHz)

3.1.1 Test Date

2021/12/19

3.1.2 Test Location

CB11: No. 68-1, Ln. 169, Sec. 2, Datong Rd., Xizhi Dist., New Taipei City 221, Taiwan (R.O.C.)

3.1.3 Limits for radiated disturbance

Table 1 – Requirements for radiated emissions at frequencies up to 1 GHz for Class A equipment.

Table clause	Frequency range MHz	Measurement			Class A limits dB(μV/m)
		Facility (see Table A.1)	Distance m	Detector type / bandwidth	
A2.1	30 to 230	OATS/SAC	10	Quasi Peak / 120 kHz	40
	230 to 1 000				47
A2.2	30 to 230	OATS/SAC	3		50
	230 to 1 000				57
A2.3	30 to 230	FAR	10	Quasi Peak / 120 kHz	42 to 35
	230 to 1 000				42
A2.4	30 to 230	FAR	3		52 to 45
	230 to 1 000				52
Apply only A2.1 or A2.2 or A2.3 or A2.4 across the entire frequency range.					

Table 2 – Requirements for radiated emissions at frequencies up to 1 GHz for Class B equipment.

Table clause	Frequency range MHz	Measurement			Class B limits dB(μV/m)
		Facility (see Table A.1)	Distance m	Detector type / bandwidth	
A4.1	30 to 230	OATS/SAC	10	Quasi Peak / 120 kHz	30
	230 to 1 000				37
A4.2	30 to 230	OATS/SAC	3		40
	230 to 1 000				47
A4.3	30 to 230	FAR	10	Quasi Peak / 120 kHz	32 to 25
	230 to 1 000				32
A4.4	30 to 230	FAR	3		42 to 35
	230 to 1 000				42
Apply only table clause A4.1 or A4.2 or A4.3 or A4.4 across the entire frequency range. These requirements are not applicable to the local oscillator and harmonics frequencies of equipment covered by Table A.6.					

The test result calculated as following:
Measurement Value = Reading Level + Correct Factor
Correct Factor = Antenna Factor + Cable Loss - Amplifier Gain(if use)
Margin Level = Measurement Value - Limit Value

3.1.4 Test Procedure

The radiated emissions test will then be repeated on the open site or chamber to measure the amplitudes accurately and without the multiple reflections existing in the shielded room. The EUT and support equipment are set up on the turntable of 10 meter semi anechoic chamber. Desktop EUT are set up on a wooden stand 0.8 meter above the ground or floor-standing arrangement shall be placed on the horizontal ground reference plane. The test volume for a height of up to 30 cm may be obstructed by absorber placed on the ground plane.

Cables connecting to AE located outside the measurement area drop directly to, but be insulated from, the RGP (or turntable where applicable), and then be routed directly to the place where they leave the test site. The thickness of the insulation is not more than 150 mm. However, cables which would normally be bonded to ground should be bonded to the RGP in accordance with normal practice or the manufacturer's recommendation.

For the initial measurements, the receiving antenna is varied from 1-4 meter height and is changed in the vertical plane from vertical to horizontal polarization at each frequency. The highest emissions between 30 MHz to 1000 MHz were analyzed in details by operating the spectrum analyzer and/or EMI receiver in quasi-peak mode to determine the precise amplitude of the emissions.

At the highest amplitudes observed, the EUT is rotated in the horizontal plane while changing the antenna polarization in the vertical plane to maximize the reading. The interconnecting cables were arranged and moved to get the maximum measurement. Once the maximum reading is obtained, the antenna elevation and polarization will be varied between specified limits to maximize the readings.
All of the interface cables were manipulated according to CISPR 32 requirements.

3.1.5 Test Equipment

Name of Equipment	Model No.	Manufacturer	Serial No.	Due Date	Applied
Log-Bicon Antenna	VULB 9168	Schwarzbeck	9168-1207	Jan. 24, 2022	YES
Attenuator	EMCI-N-6-05	Inmet	AT-N0690	Jan. 24, 2022	YES
Pre-Amplifier	EMC001330	EMCI	980144	May 11, 2022	YES
Test Cable	EMCCFD400-NM-NM-8000	EMCI	200346	May 11, 2022	YES
Test Cable	EMC104-SM-SM-2500	EMCI	150303	May 11, 2022	YES
Test Cable	EMC104-SM-NM-1000	EMCI	170311	May 11, 2022	YES
EMI Test Receiver	N9038A	Keysight	MY54130009	Jun. 07, 2022	YES
Measurement Software	EZ_EMC (Ver. NB-03A1-01)	Farad	N/A	N/A	YES

3.1.6 Test Software

N/A

3.1.7 Frequency Range of Measurement

30 MHz to 1 GHz

3.1.8 Instrument Setting

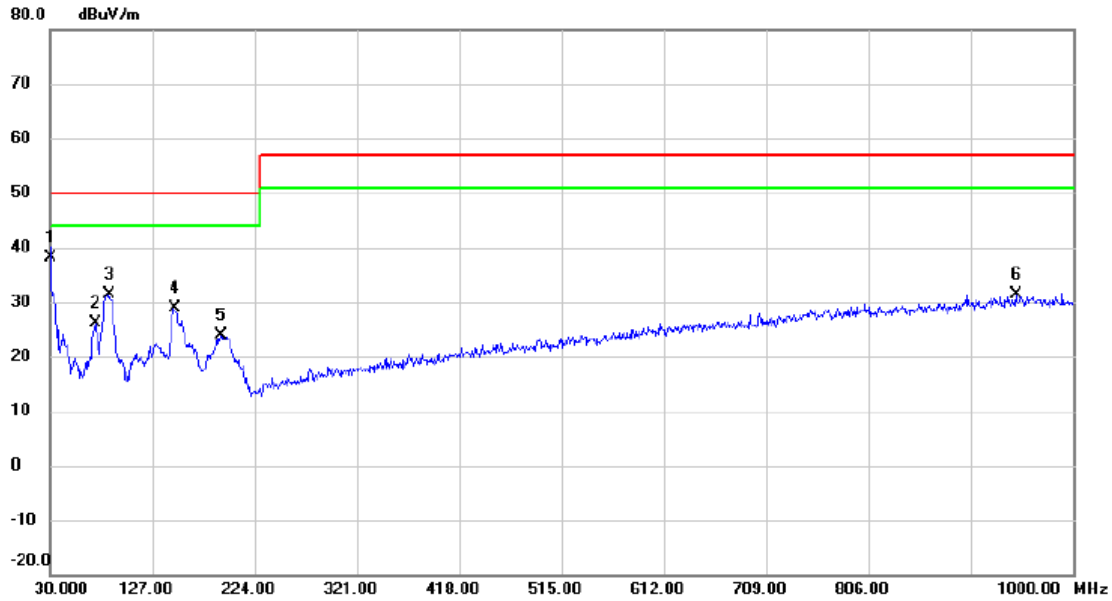
Band Width: 120 kHz.

3.1.9 Climate Condition

Temperature: 24°C
Relative Humidity: 60%

■ Operating Mode 4: Vertical

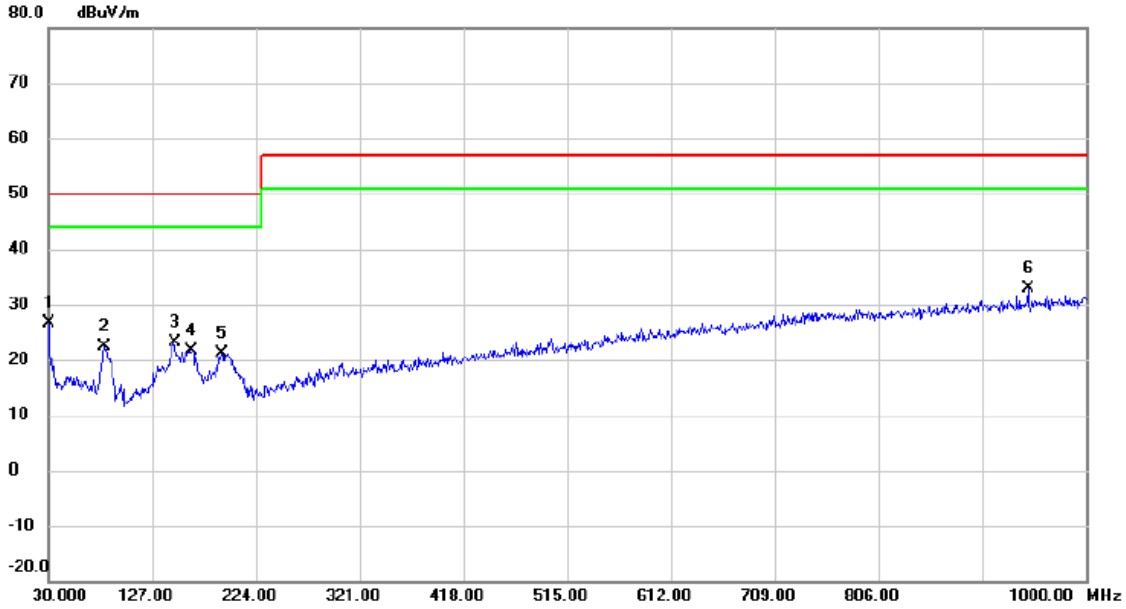
▪ Test Data & Graph



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Margin		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	30.0000	51.10	-12.87	38.23	50.00	-11.77	QP	
2		73.1650	41.16	-15.09	26.07	50.00	-23.93	QP	
3		85.7750	48.85	-17.50	31.35	50.00	-18.65	QP	
4		147.8550	40.84	-11.90	28.94	50.00	-21.06	QP	
5		192.4750	37.80	-13.95	23.85	50.00	-26.15	QP	
6		946.1650	30.31	1.16	31.47	57.00	-25.53	QP	

■ Operating Mode 4: Horizontal

▪ Test Data & Graph



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Margin		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	30.0000	39.38	-12.87	26.51	50.00	-23.49	QP	
2		82.8650	39.58	-17.11	22.47	50.00	-27.53	QP	
3		147.8550	34.92	-11.90	23.02	50.00	-26.98	QP	
4		163.3750	33.40	-11.76	21.64	50.00	-28.36	QP	
5		191.9900	35.16	-13.95	21.21	50.00	-28.79	QP	
6		946.1650	31.64	1.16	32.80	57.00	-24.20	QP	

3.2 Conducted emissions AC mains power port

3.2.1 Test Date

2021/12/14

3.2.2 Test Location

C05: No. 68-1, Ln. 169, Sec. 2, Datong Rd., Xizhi Dist., New Taipei City 221, Taiwan (R.O.C.)

3.2.3 Limits of conducted emissions AC mains power port

Table 5 – Requirements for conducted emissions from the AC mains power ports of Class A equipment.

Applicable to 1. AC mains power ports (3.1.1)				
Table clause	**Frequency range MHz**	**Coupling device (see Table A.8)**	**Detector type / bandwidth**	**Class A limits dB(μV)**
A9.1	0,15 to 0,5	AMN	Quasi Peak / 9 kHz	79
	0,5 to 30			73
A9.2	0,15 to 0,5	AMN	Average / 9 kHz	66
	0,5 to 30			60
Apply A9.1 and A9.2 across the entire frequency range.				

Table 6 – Requirements for conducted emissions from the AC mains power ports of Class B equipment.

Applicable to 1. AC mains power ports (3.1.1)				
Table clause	**Frequency range MHz**	**Coupling device (see Table A.8)**	**Detector type / bandwidth**	**Class B limits dB(μV)**
A10.1	0,15 to 0,5	AMN	Quasi Peak / 9 kHz	66 to 56
	0,5 to 5			56
	5 to 30			60
A10.2	0,15 to 0,5	AMN	Average / 9 kHz	56 to 46
	0,5 to 5			46
	5 to 30			50
Apply A10.1 and A10.2 across the entire frequency range.				

The test result calculated as following:
Measurement Value = Reading Level + Correct Factor
Correct Factor = Insertion Loss + Cable Loss + Attenuator Factor (if use)
Margin Level = Measurement Value – Limit Value

3.2.4 Test Procedure

The EUT was placed on non-conduction table, which is 0.8 meters above an earth-grounded.

Power to the EUT was provided through the LISN which has the Impedance (50ohm/50uH) vs. Frequency Characteristic in accordance with the standard. Power to the LISNs were filtered to eliminate ambient signal interference and these filters were bonded to the ground plane. Peripheral equipment required to provide a functional system (support equipment) for EUT testing was powered from the second LISN through a ganged, metal power outlet box which is bonded to the ground plane at the LISN.

Cables connecting to AE located outside the measurement area drop directly to, but be insulated from, the R GP (or turntable where applicable), and then be routed directly to the place where they leave the test site. Th e thickness of the insulation is not more than 150 mm. However, cables which would normally be bonded to ground should be bonded to the RGP in accordance with normal practice or the manufacturer's recommenda tion.

The interconnecting cables were arranged and moved to get the maximum measurement. Both the line of power cord, hot and neutral, were measured. All of the interface cables were manipulated according to CISPR 32 requirements.

The highest emissions were analyzed in details by operating the spectrum analyzer in fixed tuned mode to determine the nature of the emissions and to provide information which could be useful in reducing their amplitude.

3.2.5 Test Equipment

Name of Equipment	Model No.	Manufacturer	Serial No.	Due Date	Applied
TWO-LINE V-NETWORK	ENV216	R&S	101051	May 25, 2022	YES
Test Cable	EMCRG58-BM-BM-9000	EMCI	210501	May 02, 2022	YES
EMI Test Receiver	ESR7	R&S	101433	Dec. 10, 2021 Nov. 23, 2022	YES
Measurement Software	EZ_EMC (Ver. NB-03A1-01)	Farad	N/A	N/A	YES

3.2.6 Test Software

N/A

3.2.7 Frequency Range of Measurement

150 kHz to 30 MHz

3.2.8 Instrument Setting

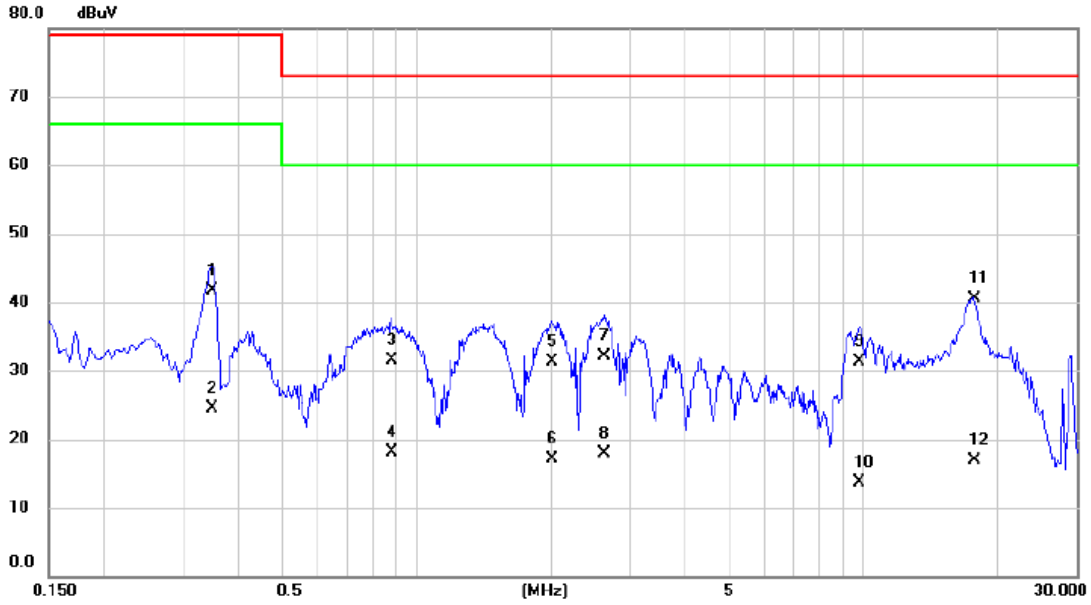
Band Width: 9 kHz.

3.2.9 Climate Condition

Temperature: 23°C
Relative Humidity: 61%

■ Operating Mode 4: Line L

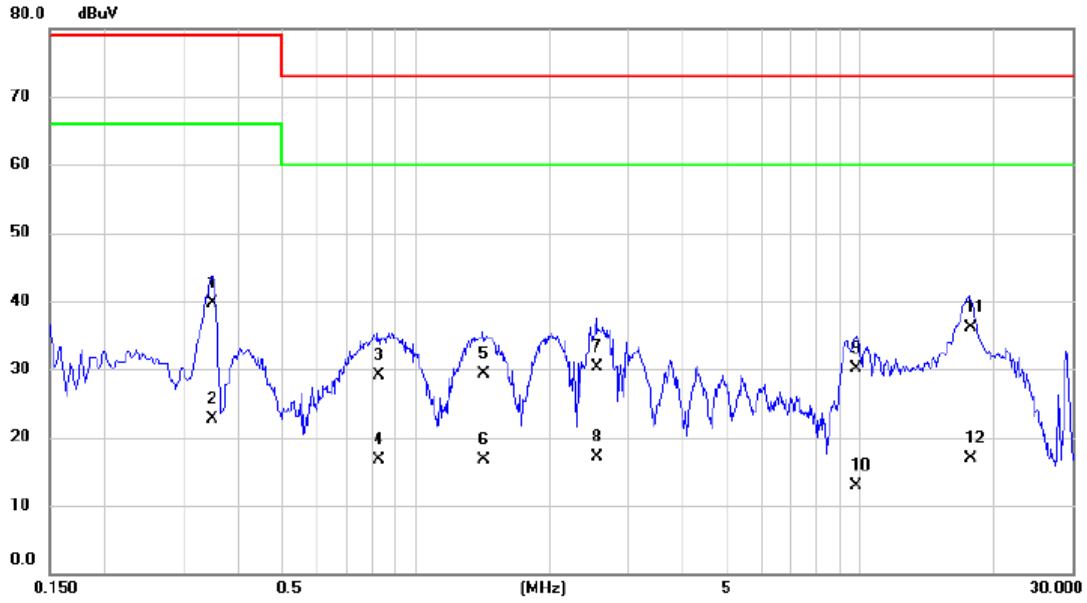
▪ Test Data & Graph



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1		0.3480	31.94	9.68	41.62	79.00	-37.38	QP	
2		0.3480	14.84	9.68	24.52	66.00	-41.48	AVG	
3		0.8790	21.80	9.69	31.49	73.00	-41.51	QP	
4		0.8790	8.40	9.69	18.09	60.00	-41.91	AVG	
5		2.0085	21.61	9.74	31.35	73.00	-41.65	QP	
6		2.0085	7.41	9.74	17.15	60.00	-42.85	AVG	
7		2.6250	22.32	9.76	32.08	73.00	-40.92	QP	
8		2.6250	8.12	9.76	17.88	60.00	-42.12	AVG	
9		9.7800	21.43	9.93	31.36	73.00	-41.64	QP	
10		9.7800	3.83	9.93	13.76	60.00	-46.24	AVG	
11	*	17.6775	30.50	9.96	40.46	73.00	-32.54	QP	
12		17.6775	7.00	9.96	16.96	60.00	-43.04	AVG	

■ Operating Mode 4: Line N

▪ Test Data & Graph



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure-ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1		0.3480	30.02	9.68	39.70	79.00	-39.30	QP	
2		0.3480	13.12	9.68	22.80	66.00	-43.20	AVG	
3		0.8250	19.47	9.69	29.16	73.00	-43.84	QP	
4		0.8250	7.07	9.69	16.76	60.00	-43.24	AVG	
5		1.4190	19.59	9.71	29.30	73.00	-43.70	QP	
6		1.4190	7.09	9.71	16.80	60.00	-43.20	AVG	
7		2.5574	20.60	9.76	30.36	73.00	-42.64	QP	
8		2.5574	7.40	9.76	17.16	60.00	-42.84	AVG	
9		9.7980	20.12	9.93	30.05	73.00	-42.95	QP	
10		9.7980	2.92	9.93	12.85	60.00	-47.15	AVG	
11	*	17.6910	26.23	9.96	36.19	73.00	-36.81	QP	
12		17.6910	6.93	9.96	16.89	60.00	-43.11	AVG	

3.3 Harmonic current emissions

3.3.1 Test Data

For equipment with a rated power of 75 W or less, limits are not specified. So the harmonic current emissions do not need to be tested.

3.4 Voltage changes, voltage fluctuations and flicker

3.4.1 Test Date

2021/09/07

3.4.2 Test Location

C05: No. 68-1, Ln. 169, Sec. 2, Datong Rd., Xizhi Dist., New Taipei City 221, Taiwan (R.O.C.)

3.4.3 Limits for voltage changes, voltage fluctuations and flicker

Table 9 – Limits for voltage changes, voltage fluctuations and flicker.

Tests	Limits	Descriptions
Pst	≤ 1.0, Tp= 10 min.	Short Term Flicker Indicator
Plt	≤ 0.65, Tp=2 hr.	Long Term Flicker Indicator
dc	≤ 3.3%	Relative Steady-State V-change
dmax	≤ 4%	Maximum Relative V-change
d (t)	≤ 500 ms	Relative V-change characteristic

3.4.4 Conditional Testing Procedure

Tests was performed according to the Test Conditions/Assessment of Voltage Fluctuations specified in **SANS 61000-3-3/IEC 61000-3-3** depend on which standard adopted for compliance measurement.

All types of harmonic current and/or voltage fluctuation in this report are assessed by direct measurement using flicker-meter.

3.4.5 Test Equipment

Name of Equipment	Model No.	Manufacturer	Serial No.	Due Date	Applied
Signal conditioning unit	PACS-1	California	72345	Mar. 10, 2022	YES
Power Source	3001iX	California	56310	Mar. 10, 2022	YES
Measurement Software	CTS 4(Version 4.26)	TESEQ	N/A	N/A	YES

3.4.6 Test Software

N/A

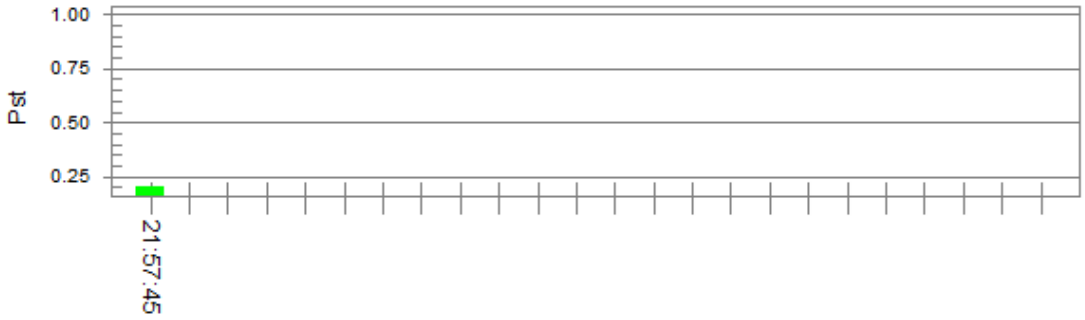
3.4.7 Climate Condition

Temperature: 26°C
Relative Humidity: 46%

■ Operating Mode 4:

▪ Test Data & Graph

Pst and limit line **European Limits**



Plt and limit line

Parameter values recorded during the test:

Vrms at the end of test (Volt):	229.66			
Highest dt (%):		Test limit (%):		
T-max (mS):	0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.00	Test limit (%):	3.30	Pass
Highest dmax (%):	0.00	Test limit (%):	4.00	Pass
Highest Pst (10 min. period):	0.201	Test limit:	1.000	Pass
Highest Plt (2 hr. period):	0.088	Test limit:	0.650	Pass

3.5 Immunity Performance Criteria and Requirements

3.5.1 Performance Criteria

Criterion A	The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion B	After the test, the equipment shall continue to operate as intended without operator Intervention. No degradation of performance or loss of function is allowed, after the application of the phenomenon below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state if stored data allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion C	Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

3.5.2 Requirements

Table 3 – Requirements for immunity

Environmental phenomenon and	Test Specification	Test Ports	Performance Criterion
Electrostatic discharge immunity	±8 kV air discharge ±4 kV contact discharge	Enclosure port	B
	±4 kV HCP discharge ±4 kV VCP discharge		B
Radiated, radio-frequency, electromagnetic field immunity	80 MHz to 1000 MHz 3V/m(unmodulated, r.m.s), 1 kHz, 80%, AM modulated	Enclosure port	A
	1800 MHz, 2600MHz, 3500 MHz, 5000MHz(±1 %) 3V/m(unmodulated, r.m.s), 1 kHz, 80%, AM modulated	Enclosure port	A
Electrical fast transient/burst immunity	±0.5kV(peak) 5/50ns Tr/Th 5kHz Repetition Frequency (100kHz Repetition Frequency for xDSL port)	Analogue/digital data ports	B
	±0.5kV(peak) 5/50ns Tr/Th 5kHz Repetition Frequency	DC network power ports	B
	±1 kV(peak) 5/50ns Tr/Th 5kHz Repetition Frequency	AC mains power ports	B

Surge immunity	Port Type: unshielded symmetrical Apply: lines to ground		
	Primary protection is Intended ±1 kV and ±4 kV 10/700(5/320)Tr/Th µs	Analogue/digital data ports	C
	Primary protection is not Intended ±1 kV 10/700(5/320) Tr/Th µs		C
	Port type: coaxial or shielded Apply: shield to ground		
	±0.5 kV 1.2/50(8/20) Tr/Th µs	Analogue/digital data ports	B
	line to reference ground for each individual line: ±0.5 kV(peak) 1.2/50(8/20) Tr/Th µs	DC network power ports	B
	±1 kV(peak) 1.2/50(8/20) Tr/Th µs (line to line) ±2 kV(peak) 1.2/50(8/20) Tr/Th µs (line to earth or ground)	AC mains power ports	B
Immunity to conducted disturbances, induced by radio-frequency fields	0.15 MHz to 10 MHz 3V(unmodulated, r.m.s), 10 MHz to 30 MHz 3V to 1V(unmodulated, r.m.s), 30 MHz to 80 MHz 1V(unmodulated, r.m.s), 1kHz 80%, AM 150Ω source impedance	Analogue/digital data ports	A
	0.15 MHz to 10 MHz 3V(unmodulated, r.m.s), 10 MHz to 30 MHz 3V to 1V(unmodulated, r.m.s), 30 MHz to 80 MHz 1V(unmodulated, r.m.s), 1kHz 80%, AM 150Ω source impedance	DC network power ports	A
	0.15 MHz to 10 MHz 3V(unmodulated, r.m.s), 10 MHz to 30 MHz 3V to 1V(unmodulated, r.m.s), 30 MHz to 80 MHz 1V(unmodulated, r.m.s), 1kHz 80%, AM 150Ω source impedance	AC mains power ports	A

Power frequency magnetic field immunity	50, 60 Hz, 1 A/m (r.m.s)	Enclosure port	A
Voltage dips, short interruptions and voltage variations immunity	Voltage dips: Residual voltage < 5% 0.5 Cycles Residual voltage < 70% 25 Cycles (50Hz), 30 Cycles (60Hz) Voltage interruptions: Residual voltage < 5% 250 Cycles (50Hz), 300 Cycles (60Hz)	Input a.c. power ports	B C C

3.6 Electrostatic discharge immunity

3.6.1 Test Date

2021/09/06

3.6.2 Test Location

SR02: No. 68-1, Ln. 169, Sec. 2, Datong Rd., Xizhi Dist., New Taipei City 221, Taiwan (R.O.C.)

3.6.3 Test Specification

Discharge Impedance	330 ohm / 150 pF
Required Performance	B
Discharge Voltage	Air Discharge: ±2 kV, ±4 kV, ±8 kV (Direct) Contact Discharge: ±2 kV, ±4 kV (Indirect)
Polarity	Positive & Negative
Number of Discharge	Air Discharge: min. 20 times at each test point Contact Discharge: min. 20 times at each test point
Discharge Mode	Single Discharge
Discharge Period	1 second minimum

3.6.4 Conditional Testing Procedure

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manner:

a. The test shall be performed with single discharges. On each pre-selected point at least 10single discharges (in the most sensitive polarity) shall be applied.
NOTE 1 The minimum number of discharges applied is depending on the EUT; for products with synchronized circuits the number of discharges should be larger. For the time interval between successive single discharges an initial value of 1 s is recommended. Longer intervals may be necessary to determine whether a system failure
has occurred. NOTE 2 The points to which the discharges should be applied may be selected by means of an exploration carried out at a repetition rate of 20 discharges per second, or more.
Vertical Coupling Plane (VCP):
The coupling plane, of dimensions 0.5m x 0.5m, is placed parallel to, and positioned at a distance 0.1m from, the EUT, with the Discharge Electrode touching the coupling plane.
The four faces of the EUT will be performed with electrostatic discharge.
Horizontal Coupling Plane (HCP):
The coupling plane is placed under to the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the Discharge Electrode touching the coupling plane.
The four faces of the EUT will be performed with electrostatic discharge.

b. Air discharges at insulation surfaces of the EUT.
It was at least ten single discharges with positive and negative at the same selected point.

3.6.5 Test Equipment

Name of Equipment	Model No.	Manufacturer	Serial No.	Due Date	Applied
ESD Simulator	GT-30RA	NoiseKen	ESS20X2776	Dec. 29, 2021	YES

3.6.6 Test Software

N/A

3.6.7 Climate Condition

Temperature: 27°C
Relative Humidity: 39%
Atmospheric Pressure: 1009hPa

■ Operating Mode 4:

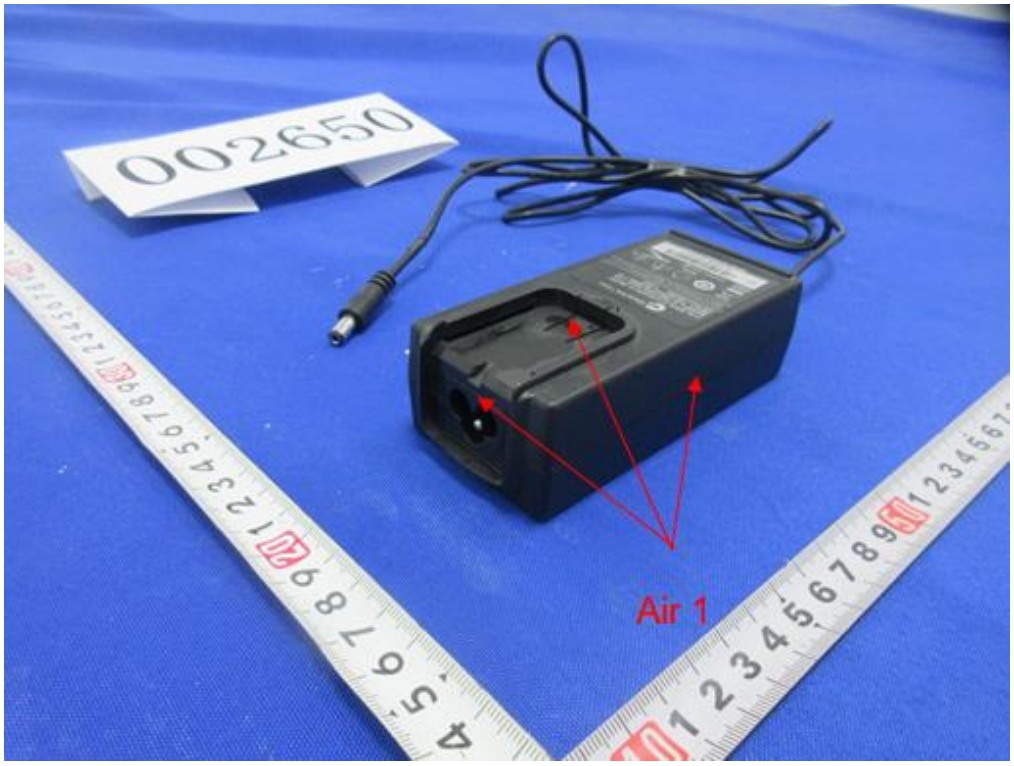
▪ Test Data & Graph

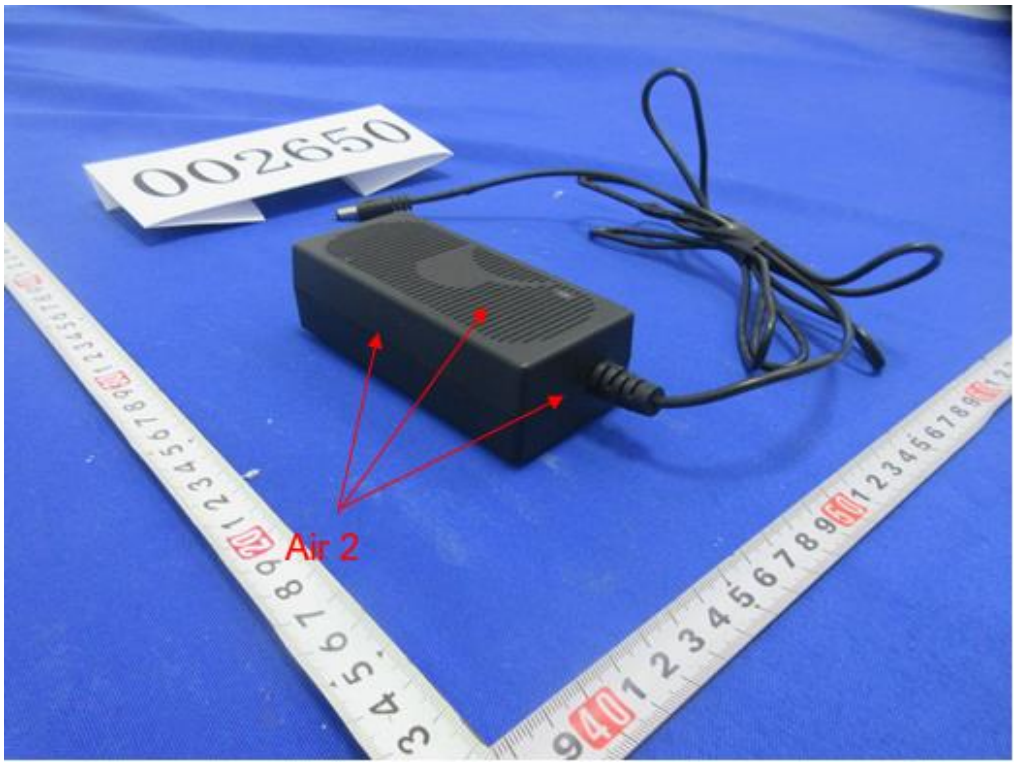
Mode	Air Discharge								Contact Discharge							
Level	2 kV		4 kV		8 kV		15 kV		2 kV		4 kV		6 kV		8 kV	
Location	P	N	P	N	P	N	P	N	P	N	P	N	P	N	P	N
1	A	A	A	A	A	A	-	-	A	A	A	A	-	-	-	-
2	A	A	A	A	A	A	-	-	-	-	-	-	-	-	-	-
Perform Criterion	B						-		B				-			
Result	A						-		A				-			
Judgment	PASS						-		PASS				-			

Mode	HCP Discharge								VCP Discharge							
Level	2 kV		4 kV		6 kV		8 kV		2 kV		4 kV		6 kV		8 kV	
Location	P	N	P	N	P	N	P	N	P	N	P	N	P	N	P	N
1	A	A	A	A	-	-	-	-	A	A	A	A	-	-	-	-
2	A	A	A	A	-	-	-	-	A	A	A	A	-	-	-	-
3	A	A	A	A	-	-	-	-	A	A	A	A	-	-	-	-
4	A	A	A	A	-	-	-	-	A	A	A	A	-	-	-	-
Perform Criterion	B				-				B				-			
Result	A				-				A				-			
Judgment	PASS				-				PASS				-			

NOTE: (1) P/N denotes the Positive/Negative polarity of the output voltage.
(2) Test condition:
Air discharges: Minimum 20 times (Positive/Negative) at each point.
Direct/Indirect (HCP/VCP) discharges: Minimum 20 times (Positive/Negative) at each point.
(3) Test location(s) in which discharge (Air and contact discharge) to be applied illustrated by photos shown in next page(s)
(4) The Indirect (HCP/VCP) discharges description of test point as following:
1. left side; 2.right side; 3.front side; 4.rear side.
(5) N/A - denotes test is not applicable in this test report

PHOTO(S) SHOWN THE LOCATION(S) OF ESD EVALUATED





3.7 Radiated, radio-frequency, electromagnetic field immunity

3.7.1 Test Date

2021/11/10

3.7.2 Test Location

CB17: No. 68-1, Ln. 169, Sec. 2, Datong Rd., Xizhi Dist., New Taipei City 221, Taiwan (R.O.C.)

3.7.3 Test Specification

Required Performance	A
Frequency Range	80 MHz - 1000 MHz 1800 MHz, 2600 MHz, 3500 MHz, 5000MHz
Field Strength	3 V/m (unmodulated, r.m.s.)
Modulation	1 kHz Sine Wave, 80%, AM Modulation
Frequency Step	1% of fundamental
Polarity of Antenna	Horizontal and Vertical
Test Distance	3 m
Antenna Height	1.55 m
Dwell Time	at least 3 seconds

3.7.4 Conditional Testing Procedure

The EUT and support equipment, which are placed on a table that is 0.8 meter above ground and the testing was performed in a fully-anechoic chamber.
The testing distance from antenna to the EUT was 3 meters.
The other condition as following manner:

a. The field strength is 3 V/m (unmodulated, r.m.s.).
b. The frequency ranges are swept with the signal 80% amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5x 10-3 decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
d. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

3.7.5 Test Equipment

Name of Equipment	Model No.	Manufacturer	Serial No.	Due Date	Applied
Signal Generator	AT1080	KEYSIGHT	MY56200462	Aug. 09, 2022	YES
Log-Periodic Antenna	80RF1000-300	AR	320290	N/A	YES
Power Amplifier	STLP 9149	AMETEK	1079823	N/A	YES
Stacked Microwave Log.-Per. Antenna	AS0860B-50/50	SCHWARZBECK	524	N/A	YES
Power Amplifier	SMP2	AMETEK	1081874	N/A	YES
Readout Unit	WPF8	WAVECONTROL	20SN1431	Feb. 08, 2022	YES
E-Field Probe	4232A	WAVECONTROL	20WP041180	Feb. 08, 2022	YES
RF Power Meter	51075A	BOONTON	12871	Nov. 19, 2021 Nov. 04, 2022	YES
Power Sensor	51075A	BOONTON	36942	Nov. 19, 2021 Nov. 04, 2022	YES
Power Sensor	AT1080	BOONTON	36943	Nov. 19, 2021 Nov. 04, 2022	YES
Measurement Software	i2(Version 5.161006)	AUDIX	N/A	N/A	YES

3.7.6 Test Software

N/A

3.7.7 Climate Condition

Temperature: 22°C
Relative Humidity: 34%

■ Operating Mode 4:

▪ Test Data

Frequency (MHz)	Applied Voltage(V/m) – 80% AM 1kHz	Polarity	Azimuth	Criterion	Observation	Result
80~1000	3	V & H	Rear	A	A	PASS
			Front		A	
			Left		A	
			Right		A	
1800(±1%)	3	V & H	Rear	A	A	PASS
			Front		A	
			Left		A	
			Right		A	
2600(±1%)	3	V & H	Rear	A	A	PASS
			Front		A	
			Left		A	
			Right		A	
3500(±1%)	3	V & H	Rear	A	A	PASS
			Front		A	
			Left		A	
			Right		A	
5000(±1%)	3	V & H	Rear	A	A	PASS
			Front		A	
			Left		A	
			Right		A	

NOTE: (1) N/A - denotes test is not applicable in this test report

3.8 Electrical fast transient/burst immunity

3.8.1 Test Date

2021/11/05

3.8.2 Test Location

SR01: No. 68-1, Ln. 169, Sec. 2, Datong Rd., Xizhi Dist., New Taipei City 221, Taiwan (R.O.C.)

3.8.3 Test Specification

Required Performance	B
Test Voltage	AC mains power ports: ±1 kV
Polarity	Positive & Negative
Impulse Frequency	5 kHz: except for xDSL ports
Impulse Wave shape	5/50 ns
Burst Duration	15 ms
Burst Period	300 ms
Test Duration	Not less than 1 min.
Dwell Time	at least 3 seconds

3.8.4 Conditional Testing Procedure

The EUT and support equipment(s) are placed on a table that is 0.8 meter high above a metal ground plane and should be located 0.1 m+/- 0.01m high above the Ground Reference Plane (1m*1m min. and 0.65mm thick min).
The other condition as following manner:

a. Both positive and negative polarity discharges were applied.
b. The duration time of each test sequential was 1 minute.

3.8.5 Test Equipment

Name of Equipment	Model No.	Manufacturer	Serial No.	Due Date	Applied
EMC Immunity Test System	NSG 3060	TESEQ	4026	Nov. 17, 2021 Feb. 21, 2022	YES
EMC Immunity Test System	CDN 3061	TESEQ	5012	Nov. 17, 2021 Feb. 21, 2022	YES
Single motor driven variable transformer	VAR 3005-S16	TESEQ	3009	Nov. 17, 2021 Feb. 21, 2022	YES
Measurement Software	SUI 3000 (V02.31)	TESEQ	N/A	N/A	YES

3.8.6 Test Software

N/A

3.8.7 Climate Condition

Temperature: 19°C
Relative Humidity: 36%

■ Operating Mode 4:

▪ Test Data

AC Power Ports –5/50Tr/Th ns						
Tested on	Test Voltage(kV)		Pulse Rate	Criterion	Observation	Result
L	+/-	1	5kHz	B	A	PASS
N	+/-	1	5kHz	B	A	
PE	+/-	1	5kHz	B	A	
L+N	+/-	1	5kHz	B	A	
L+PE	+/-	1	5kHz	B	A	
N+PE	+/-	1	5kHz	B	A	
L+N+PE	+/-	1	5kHz	B	A	

NOTE: (1) +/- denotes the Positive/Negative polarity of the output voltage.
(2) N/A - denotes test is not applicable in this test report

3.9 Surge immunity

3.9.1 Test Date

2021/11/12

3.9.2 Test Location

SR01: No. 68-1, Ln. 169, Sec. 2, Datong Rd., Xizhi Dist., New Taipei City 221, Taiwan (R.O.C.)

3.9.3 Test Specification

Required Performance	B
Waveform	Input a.c. power ports: 1.2/50 µs Open Circuit Voltage 8 /20 µs Short Circuit Current
Test Voltage	Input a.c. power ports: Line to line: ±1 kV Line to earth: ±2 kV
Surge Input/Output	L-N, L-PE, N-PE
Generator Source Impedance	2 Ω of the low-voltage power supply network. 12 Ω (10Ω+2Ω) of the low-voltage power supply network and ground.
Phase Angle and Polarity:	Five positive pulses line-to-neutral at 90°phase Five negative pulses line-to-neutral at 270°phase
Pulse Repetition Rate	1 time / min. (maximum)
Number of Tests	5 positive and 5 negative at selected points

3.9.4 Conditional Testing Procedure

a. For EUT power supply:
The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2meters in length (or shorter).

b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT:
The surge is applied to the lines via the capacitive coupling. The coupling /decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

c. For test applied to unshielded symmetrically operated interconnection /telecommunication lines of EUT:
The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

3.9.5 Test Equipment

Name of Equipment	Model No.	Manufacturer	Serial No.	Due Date	Applied
EMC Immunity Test System	NSG 3060	TESEQ	4026	Nov. 17, 2021 Feb. 21, 2022	YES
EMC Immunity Test System	CDN 3061	TESEQ	5012	Nov. 17, 2021 Feb. 21, 2022	YES
Single motor driven variable transformer	VAR 3005-S16	TESEQ	3009	Nov. 17, 2021 Feb. 21, 2022	YES
Measurement Software	SUI 3000 (V02.31)	TESEQ	N/A	N/A	YES

3.9.6 Test Software

N/A

3.9.7 Climate Condition

Temperature: 19°C
Relative Humidity: 36%

■ Operating Mode 4:

▪ Test Data

Test Result for AC Power – 1.2/50(8/20)Tr/Thμs									
Tested on	Phase	Polarity	Test Voltage(kV)				Criterion	Observation	Result
			0.5	1	2	4			
L-N	90°	+	-	A	-	-	B	A	PASS
	270°	-	-	A	-	-			
L-PE	90°	+	-	-	A	-	B	A	PASS
	270°	-	-	-	A	-			
N-PE	90°	+	-	-	A	-	B	A	PASS
	270°	-	-	-	A	-			

NOTE: (1) Polarity and Numbers of Impulses: 5 Pst / Ngt at each tested mode.
(2) N/A - denotes test is not applicable in this test report

3.10 Immunity to conducted disturbances, induced by radio-frequency fields

3.10.1 Test Date

2021/09/07

3.10.2 Test Location

SR01: No. 68-1, Ln. 169, Sec. 2, Datong Rd., Xizhi Dist., New Taipei City 221, Taiwan (R.O.C.)

3.10.3 Test Specification

Required Performance	A
Frequency Range	0.15 to 80 MHz
Field Strength	3 V (unmodulated, r.m.s.)
Modulation	1 kHz Sine Wave, 80 %, AM Modulation
Frequency Step	1 % of fundamental
Dwell Time	at least 3 seconds

3.10.4 Conditional Testing Procedure

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1 m x 1 m minimum and 0.65 mm thick minimum.
The other condition as following manner:

a. The field strength is 3 V (unmodulated, r.m.s.).
b. The frequency range is swept from 0.15 to 80 MHz, with the signal 80% amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5 x 10^{-3} decade/s. Where the frequency range is swept incrementally, the step size was 1 % of fundamental.
c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.

3.10.5 Test Equipment

Name of Equipment	Model No.	Manufacturer	Serial No.	Due Date	Applied
Test System for Conducted and Radiated Immunity	NSG 4070	TESEQ	30593	Aug. 02, 2022	YES
CDN (M3)	CDN M016	TESEQ	42157	Dec. 22, 2021 Nov. 23, 2022	YES
Measurement Software	NSG 4070 Control Program(Version 1.2)	TESEQ	N/A	N/A	YES

3.10.6 Test Software

N/A

3.10.7 Climate Condition

Temperature: 26°C
Relative Humidity: 46%

■ Operating Mode 4:

▪ Test Data

Test Result for Power – 80% AM 1kHz					
Tested on	Frequency (MHz)	Applied Voltage (V (unmodulated, r.m.s.))	Criterion	Observation	Result
AC	0.15 - 10	3	A	A	PASS
	10 - 30	3 - 1	A	A	PASS
	30 - 80	1	A	A	PASS

NOTE: (1) N/A - denotes test is not applicable in this test report

3.11 Power frequency magnetic field immunity

3.11.1 Test Date

2021/11/05

3.11.2 Test Location

SR03: No. 68-1, Ln. 169, Sec. 2, Datong Rd., Xizhi Dist., New Taipei City 221, Taiwan (R.O.C.)

3.11.3 Test Specification

Required Performance	A
Frequency Range	50 or 60 Hz
Field Strength	1 A/m
Observation Time	1 minute
Inductance Coil	Rectangular type, 1mx1m

3.11.4 Conditional Testing Procedure

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1 m x 1 m minimum and 0.65 mm thick minimum.
The other condition as following manner:

a. The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.
b. The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

3.11.5 Test Equipment

Name of Equipment	Model No.	Manufacturer	Serial No.	Due Date	Applied
Triaxial ELF Magnetic Fiedl Meter	4190	F.W. BELL	0932008	Jun. 14, 2022	YES
Magnetic Field Test Generator	MFO 6501	TESEQ	1010	Nov. 07, 2021 Nov. 04, 2022	YES
Magnetic Field Immunity Loop	INA 702	TESEQ	334	Nov. 07, 2021 Nov. 04, 2022	YES

3.11.6 Test Software

N/A

3.11.7 Climate Condition

Temperature: 20°C
Relative Humidity: 45%

■ Operating Mode 4:

▪ Test Data

Test Frequency (Hz)	Magnetic Field (A/m)	Direction	Criterion	Observation	Result
50	1	X Y Z	A	A	PASS
60	1	X Y Z	A	A	PASS

NOTE: (1) N/A - denotes test is not applicable in this test report

3.12 Voltage dips, short interruptions and voltage variations immunity

3.12.1 Test Date

2021/11/12

3.12.2 Test Location

SR01: No. 68-1, Ln. 169, Sec. 2, Datong Rd., Xizhi Dist., New Taipei City 221, Taiwan (R.O.C.)

3.12.3 Test Specification

Required Performance	Voltage dips: (B) Residual voltage < 5% 0.5 cycles (C) Residual voltage70% 25 cycles(50Hz), 30 cycles(60Hz) Voltage interruptions: (C) Residual voltage < 5% 250 cycles(50Hz), 300 cycles(60Hz)
Test Duration Time	Minimum three test events in sequence
Interval between Event	10 s minimum
Phase Angle	0°/180°
Test Cycle	3 times

3.12.4 Conditional Testing Procedure

The EUT shall be tested for each selected combination of test levels and duration with a sequence of three dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at zero crossings of the voltage waveform.

3.12.5 Test Equipment

Name of Equipment	Model No.	Manufacturer	Serial No.	Due Date	Applied
EMC Immunity Test System	NSG 3060	TESEQ	4026	Nov. 17, 2021 Feb. 21, 2022	YES
EMC Immunity Test System	CDN 3061	TESEQ	5012	Nov. 17, 2021 Feb. 21, 2022	YES
Single motor driven variable transformer	VAR 3005-S16	TESEQ	3009	Nov. 17, 2021 Feb. 21, 2022	YES
Measurement Software	SUI 3000(V02.31)	TESEQ	N/A	N/A	YES

3.12.6 Test Software

N/A

3.12.7 Climate Condition

Temperature: 19°C
Relative Humidity: 36%

■ Operating Mode 4:

▪ Test Data

100Vac/50Hz				
Voltage Residual	Periods	Criterion	Observation	Result
＜5%	0.5	B	A	PASS
70%	25	C	A	
＜5%	250	C	B	

230Vac/50Hz				
Voltage Residual	Periods	Criterion	Observation	Result
＜5%	0.5	B	A	PASS
70%	25	C	A	
＜5%	250	C	B	

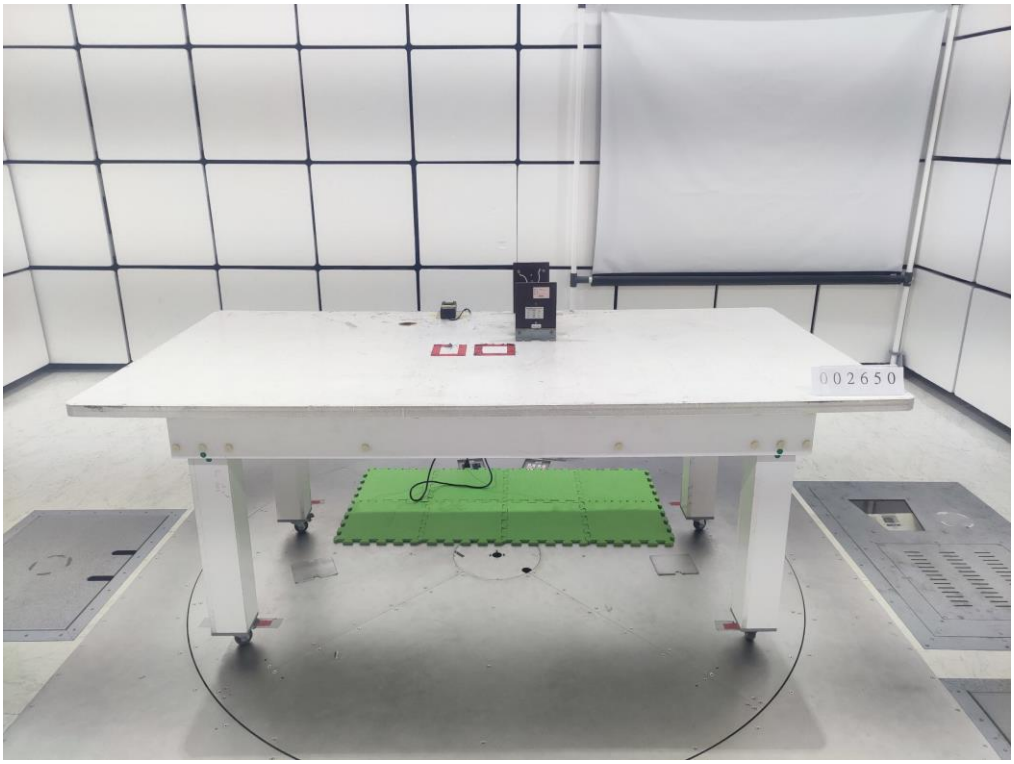
240Vac/50Hz				
Voltage Residual	Periods	Criterion	Observation	Result
＜5%	0.5	B	A	PASS
70%	25	C	A	
＜5%	250	C	B	

NOTE: (1) N/A - denotes test is not applicable in this test report

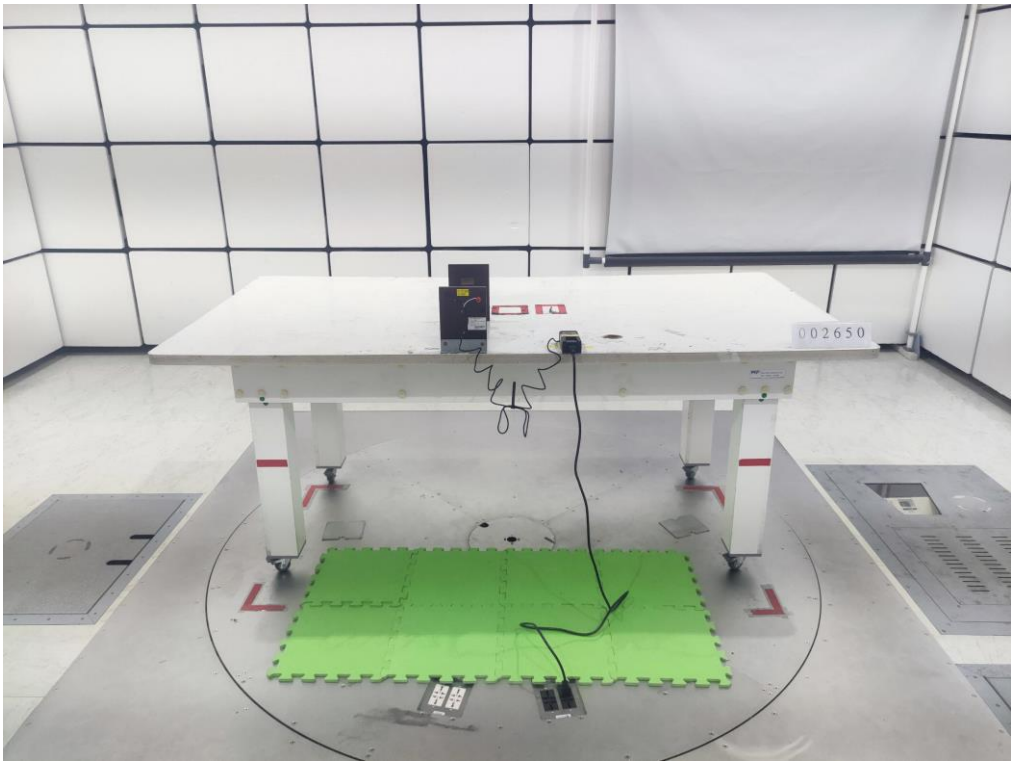
4.0 APPENDIX A - Test Setup Photos and Configuration

CONTINUE ON NEXT PAGE

4.1 Radiated disturbance (Up to 1 GHz)



[Front]



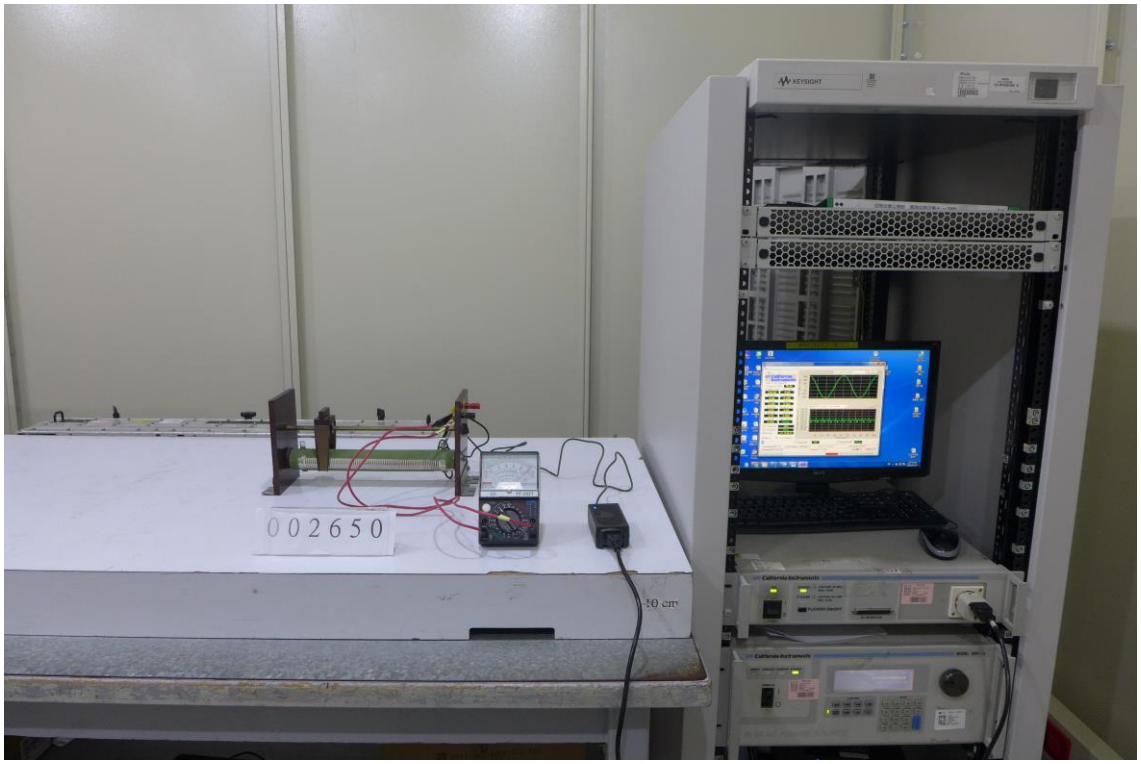
[Rear]

4.2 Conducted emissions AC mains power port

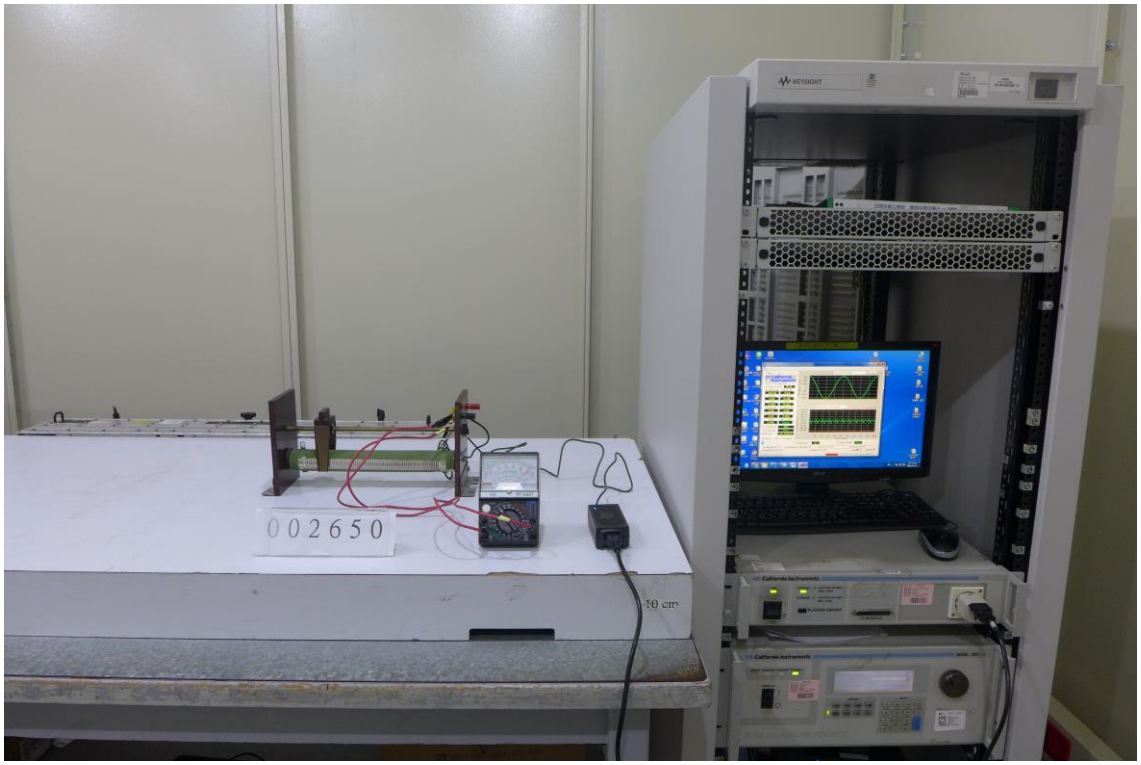
[Front]

[Rear]

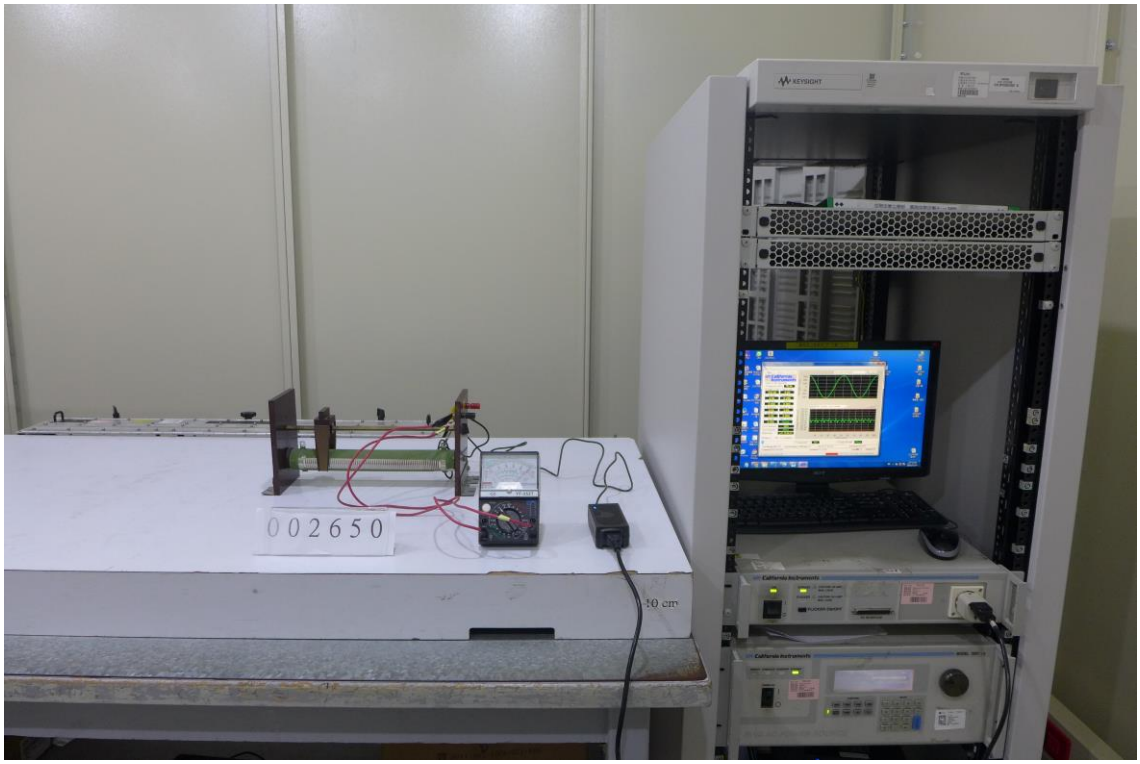
4.3 Voltage changes, voltage fluctuations and flicker



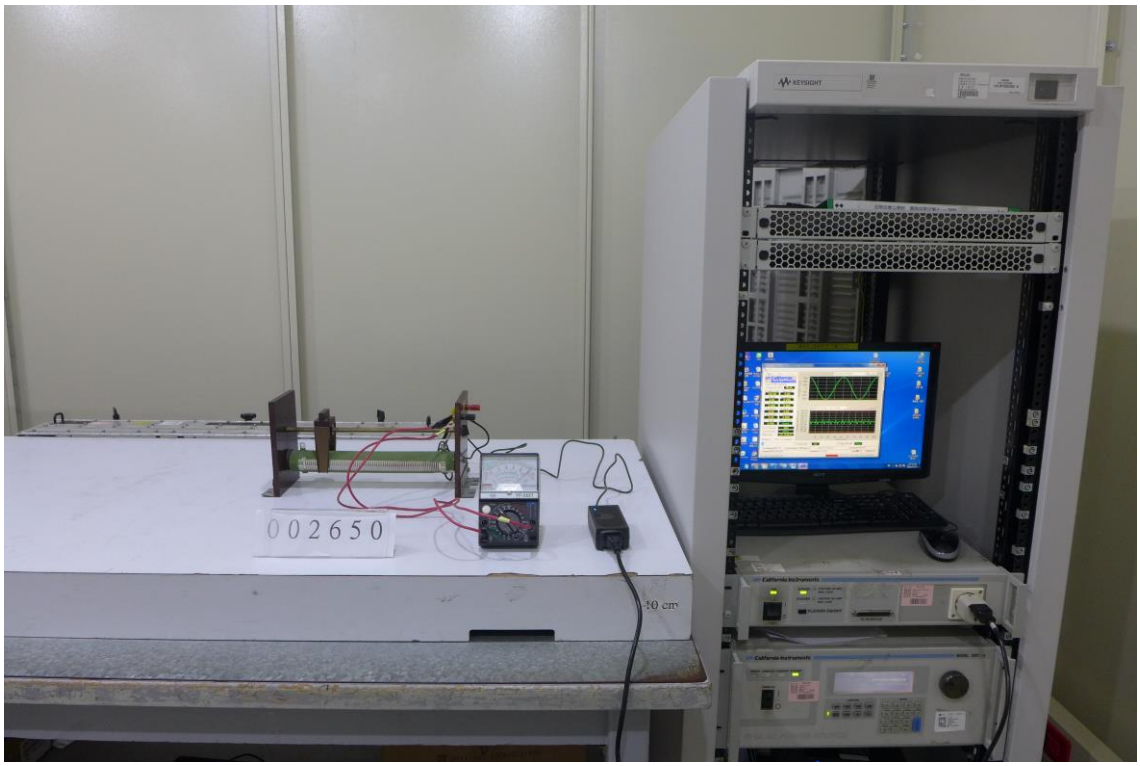
4.4 Electrostatic discharge immunity



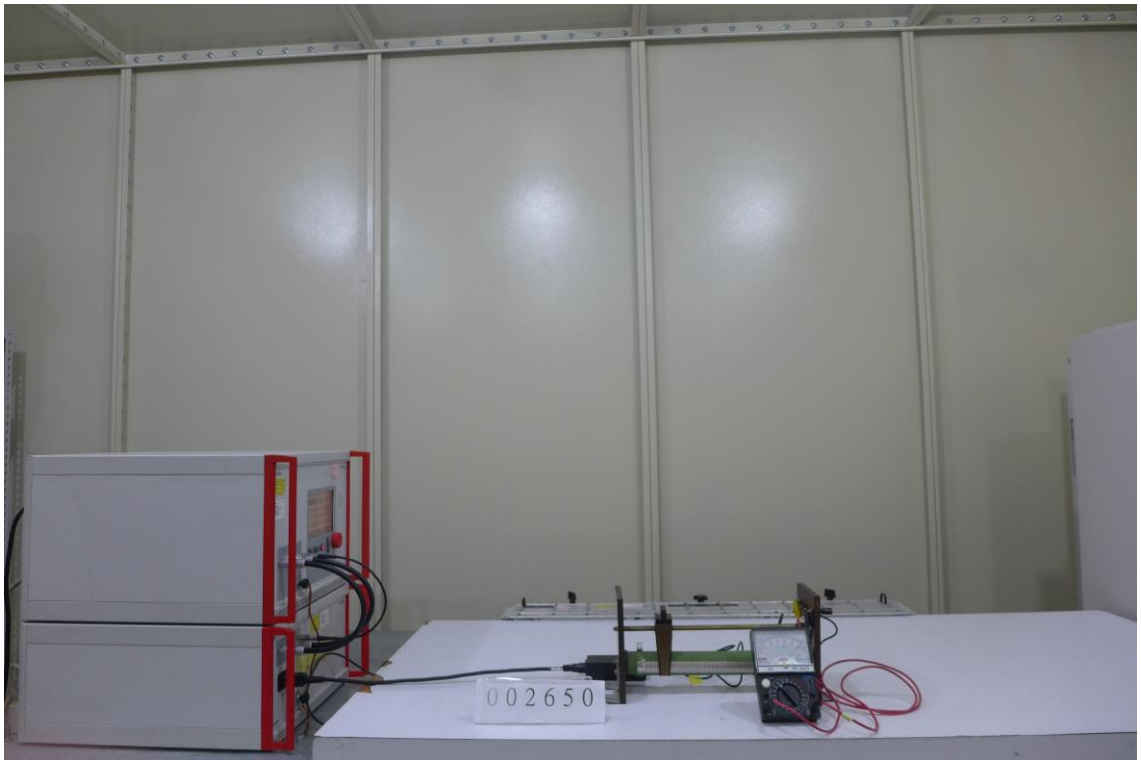
4.5 Radiated, radio-frequency, electromagnetic field immunity



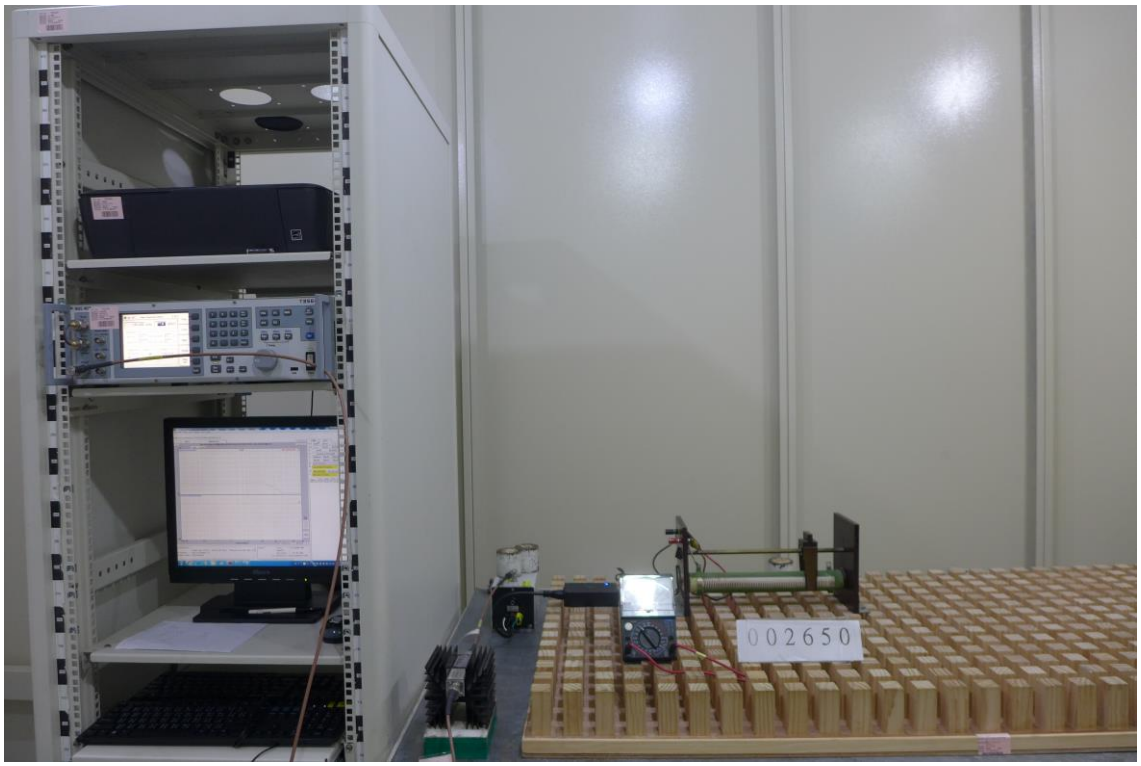
4.6 Electrical fast transient/burst immunity



4.7 Surge immunity

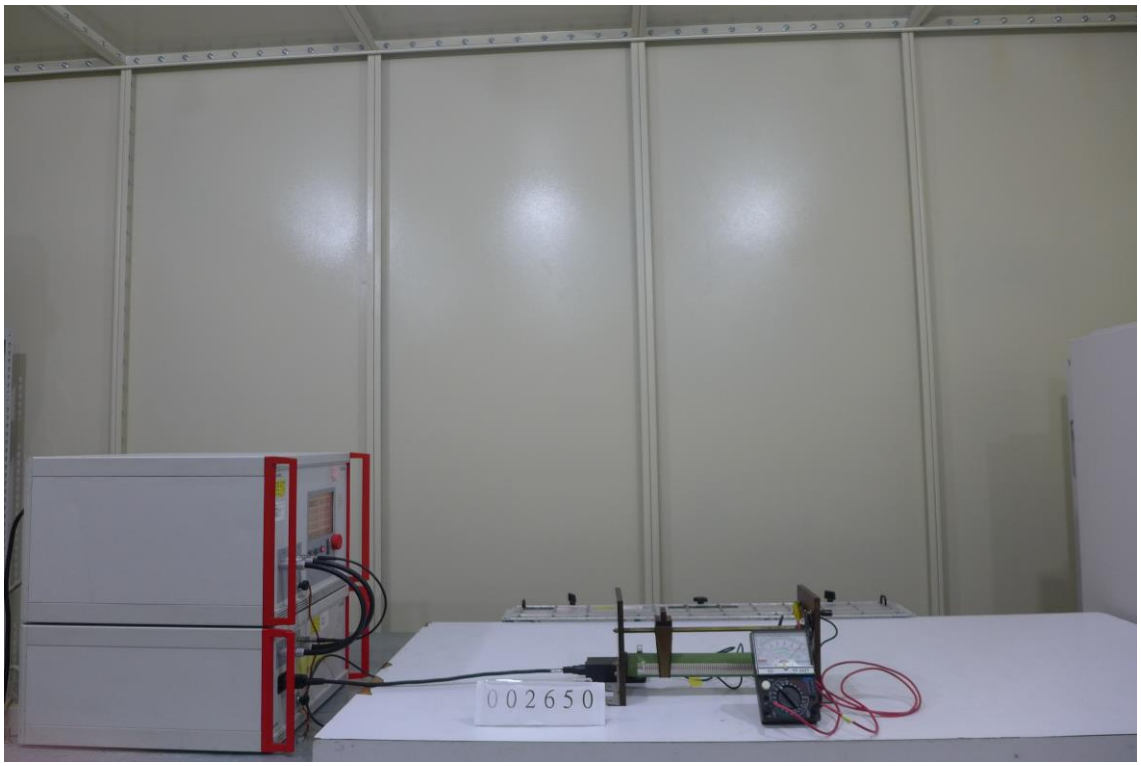


4.8 Immunity to conducted disturbances, induced by radio-frequency fields



4.9 Power frequency magnetic field immunity

4.10 Voltage dips, short interruptions and voltage variations immunity



5.0 APPENDIX B – EUT Photographs

CONTINUE ON NEXT PAGE

5.1 EUT External Photographs

GTM91099-6024-8.0-T2

[Front & Side]

[Rear & Side]

GlobTek, Inc.
www.globtek.com
MEDICAL / ITE POWER SUPPLY
S/N:
MADE IN CHINA / Hecho en China /Feito em China/

[Label]

GTM91099-6015-3.0-T3A

[Front & Side]

[Rear & Side]

GlobTek, Inc.
www.globtek.com
POWER SUPPLY
ITE/MEDICAL POWER SUPPLY
P/N(料号):RR9LE5000LCPCIMRVB
MODEL(型号):GTM91099-6015-3.0-T3A
INPUT(输入):100-240V~,50-60Hz,1.5A
OUTPUT(输出):12V 5A
Apparatet må tilkoples jordet stikkontakt
IEC/EN60950-1
IEC/EN60335-1
IEC/EN60601-1
LPS
IP40
E341350
LISTED
E341351
N136
SAA130844EA
GlobTek, Inc.
EFFICIENCY LEVEL V
RoHS 2
S/N:
RoHS500264121/14
MADE IN CHINA 中国制造

[Label]

GTM91099-3009-4.0-T3A

[Front & Side]

[Rear & Side]

GlobTek, Inc.
www.globtek.com
POWER SUPPLY
MEDICAL/ITE POWER SUPPLY
P/N: RR9LA6000Z00CIM(RVB)
MODEL: GTM91099-3009-4.0-T3A
INPUT: 100-240V~, 50-60Hz, 1.5A
OUTPUT: 5V 6.0 A
IEC/EN 60950-1
IEC/EN 60335-1
IEC/EN 60601-1
E341350
LISTED
GlobTek, Inc.
EFFICIENCY LEVEL V
S/N:
RoHS558219119/14
MADE IN CHINA
RoHS 2

[Label]

GTM91099-6024-T3A

[Front & Side]

[Rear & Side]

GlobTek, Inc.
www.globtek.com
MEDICAL / ITE POWER SUPPLY
FONTE DE ALIMENTAÇÃO
PART NO/PARTE/料号: RR9LI2500Z00CIM(RVB)
MODEL/MODELO/型号: GTM91099-6024-T3A
INPUT/ENTRADA/输入: 100-240 V~, 50-60Hz, 1.5A
OUTPUT/SAÍDA/输出: 24V ⎓ 2.5A
IEC/EN 60950-1
IEC/EN 60335-1
IEC/EN 60601-1
E341250
Apparatet må tilkoples jordet stikkontakt
GlobTek, Inc.
LISTED E341391
I.T.E.POWER SUPPLY
IP62 LPS
RoHS 2
S/N:
RoHS356858143/14
MADE IN CHINA /Feito em China/ 中国制造

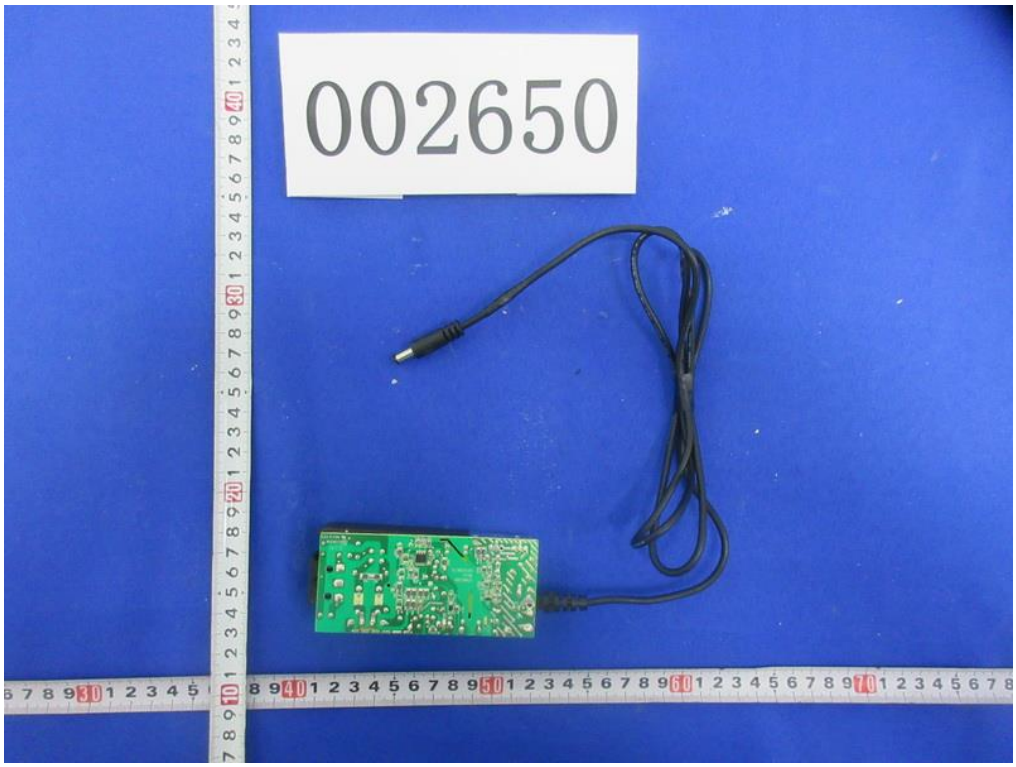
[Label]

5.2 EUT Internal Photographs

CONTINUE ON NEXT PAGE

GTM91099-6024-8.0-T2

[Removed Back Cover]

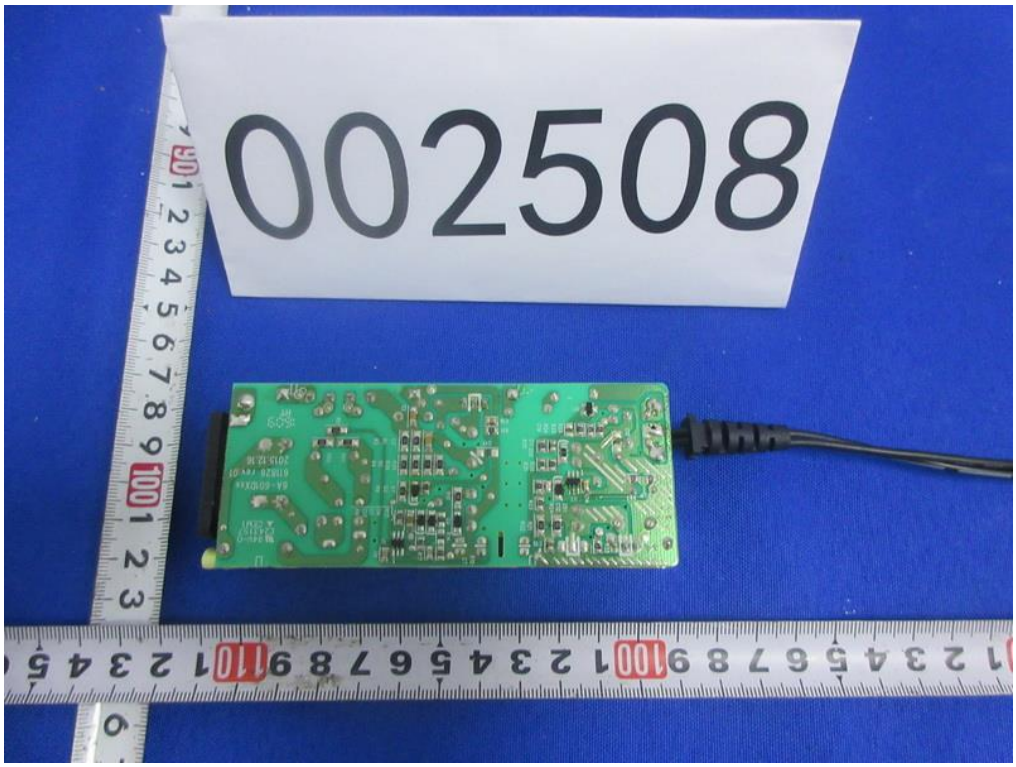


Main Board [Front]

Main Board [Rear]

GTM91099-6015-3.0-T3A

[Removed Back Cover]

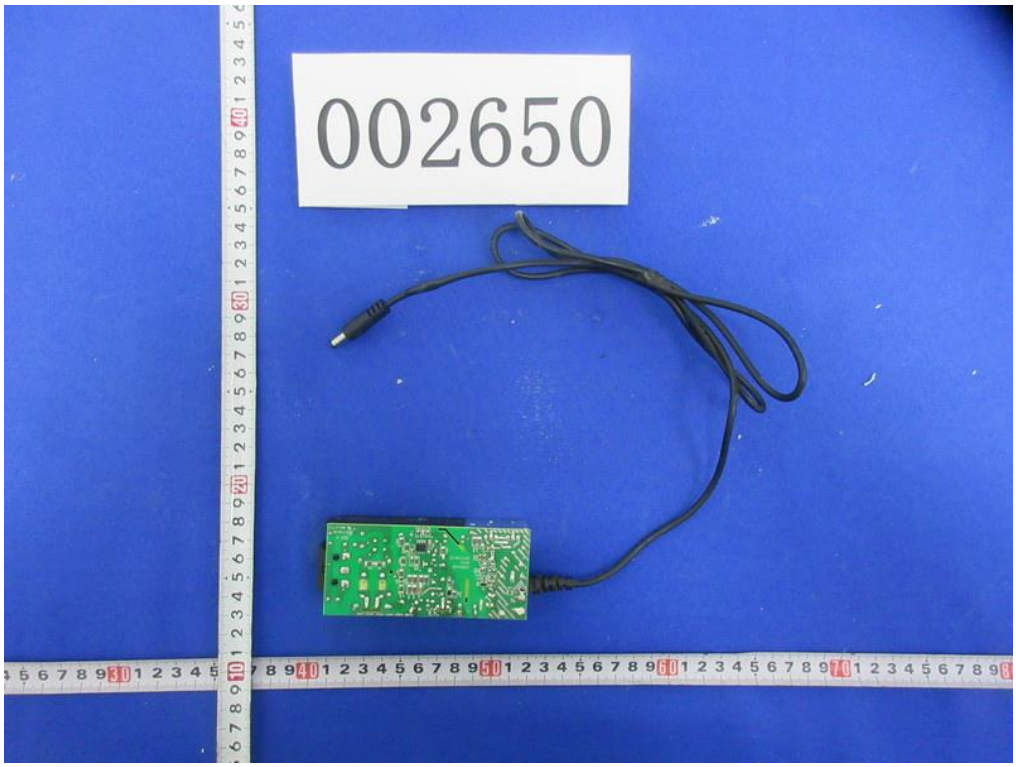


Main Board [Front]

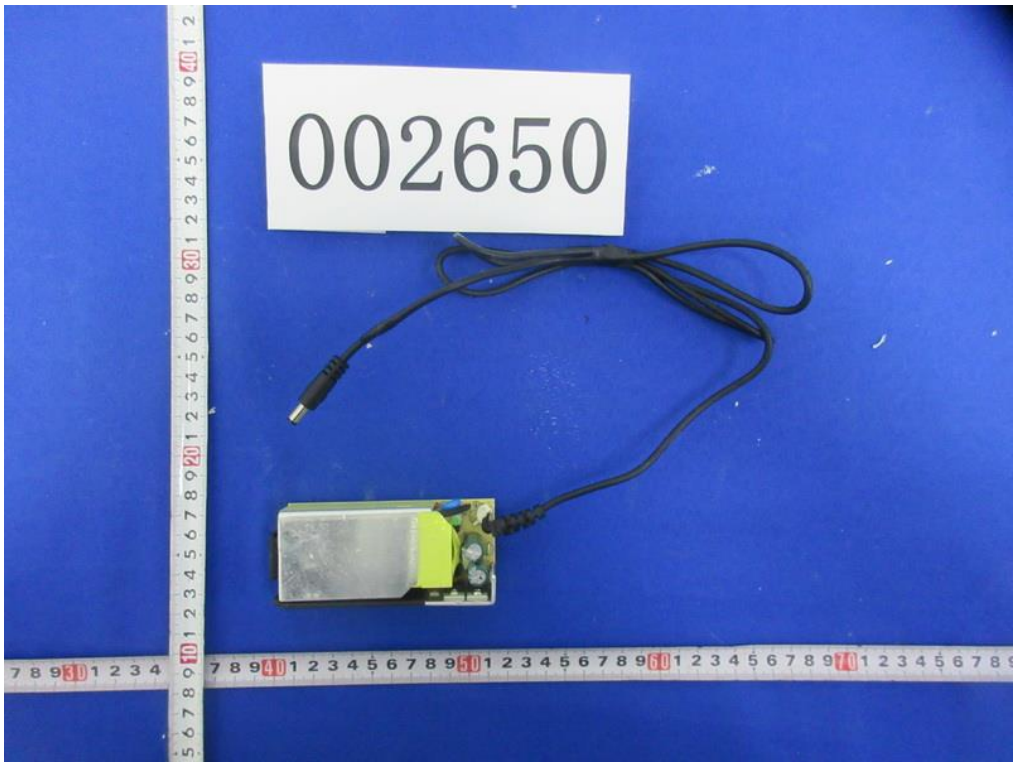
Main Board [Rear]

GTM91099-3009-4.0-T3A

[Removed Back Cover]



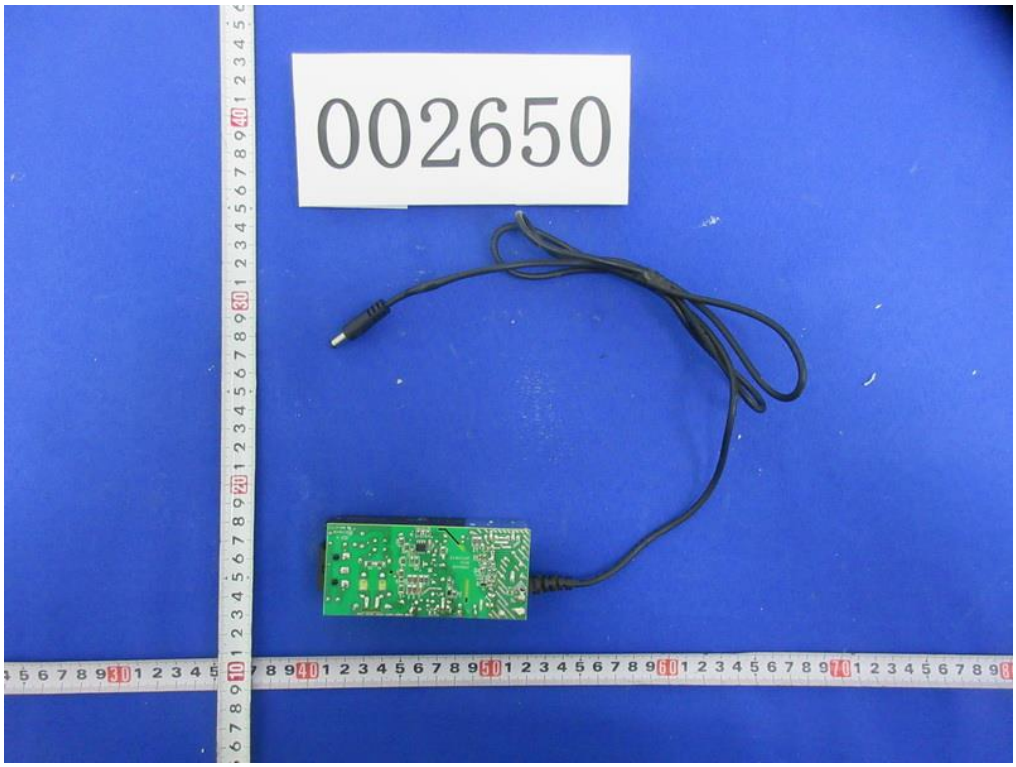
Main Board [Front]



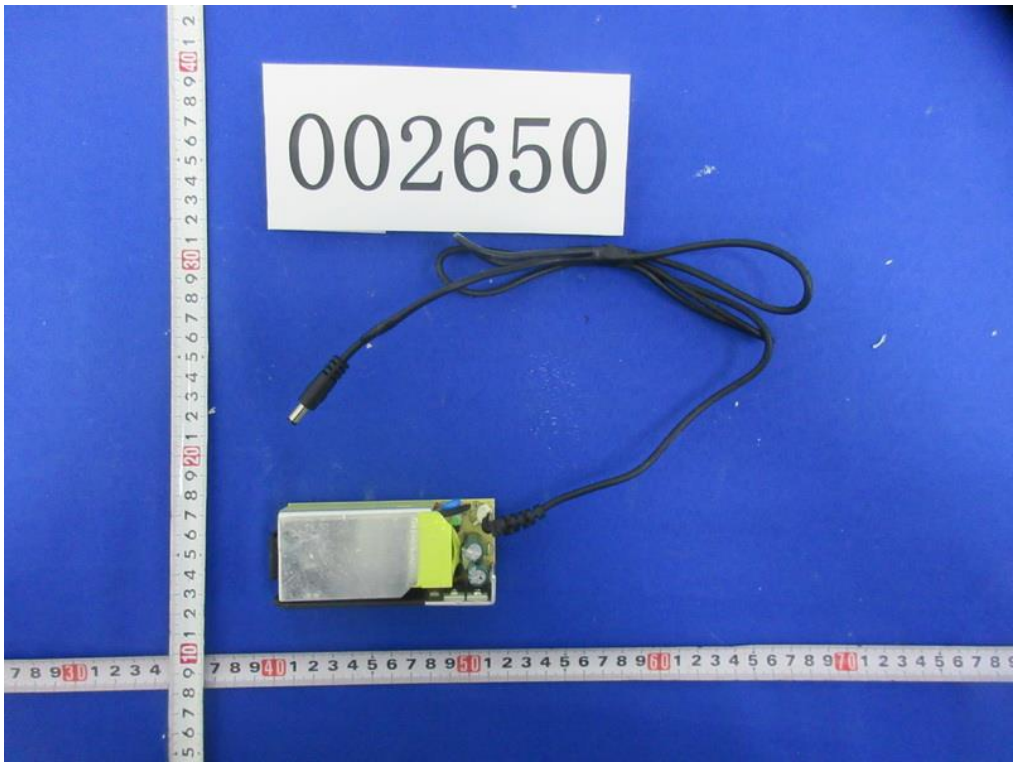
Main Board [Rear]

GTM91099-6024-T3A

[Removed Back Cover]

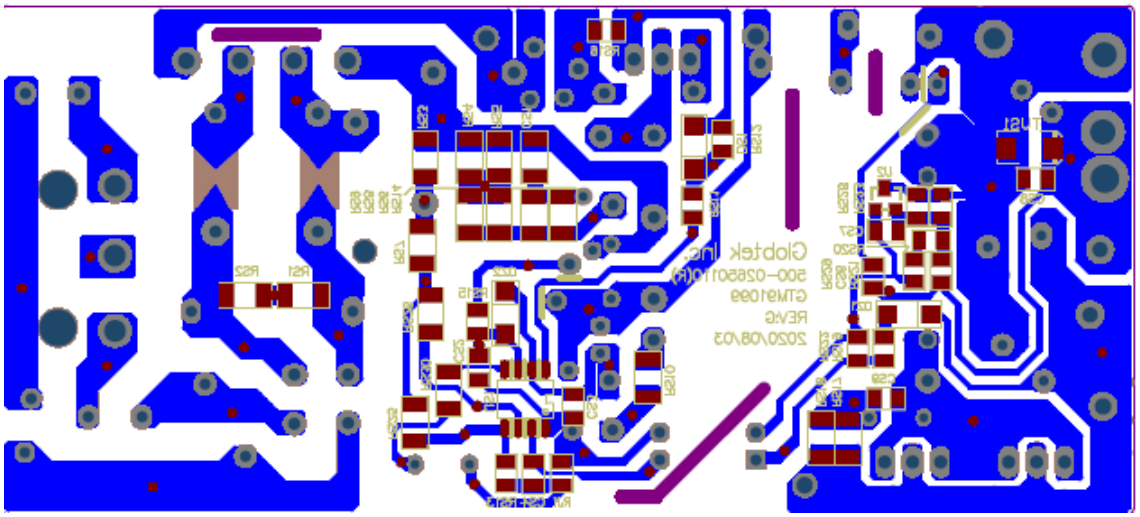


Main Board [Front]

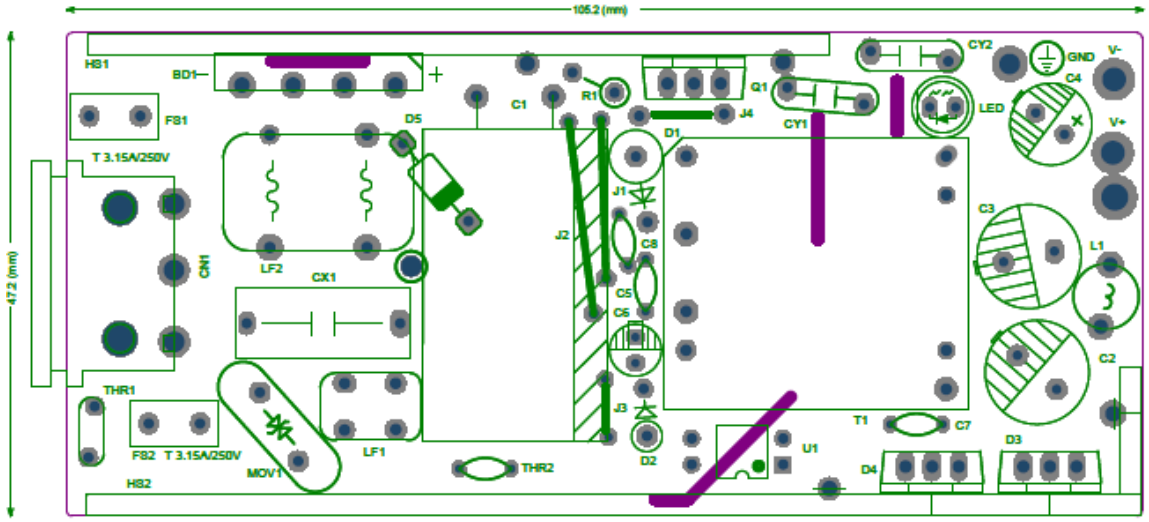


Main Board [Rear]

5.3 PCB



[Main board]



[Main board]

5.4 Label and Location

[Label 1]

[Location]

6.0 APPENDIX C – Critical Component List

CONTINUE ON NEXT PAGE

Critical Component List

Object/part No.	Manufacturer/ trademark	Type/model	Technical data	Standard (Edition / year)	Mark(s) of conformity[1])
PCB	WALEX ELECTRONIC (WUXI) CO LTD	T2, T2A, T2B T4	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E154355
Alt. use	DONGGUAN HE TONG ELECTRONICS CO LTD	CEM1 2V0 FR4	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E243157
Alt. use	CHEERFUL ELECTRONIC (HK) LTD	02 03 03A	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E199724
Alt. use	DONGGUAN DAYSUN ELECTRONIC CO LTD	DS2	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E251754
Alt. use	DAFENG AREX ELECTRONICS TECHNOLOGY CO LTD	02V0 03V0 04V0	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E186016
Alt. use	BRITE PLUS ELECTRONICS (SUZHOU) CO LTD	DKV0-3A DGV0-3A	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E177671
Alt. use	KUOTIANG ENT LTD	C-2 C-2A	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E227299
Alt. use	SHENZHEN TONGCHUANGXI N ELECTRONICS CO LTD	TCX	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E250336
Alt. use	PACIFIC WIN INDUSTRIAL LTD	PW-02 PW-03	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E228070
Alt. use	YUANMAN PRINTED CIRCUIT CO LTD	1V0	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E74757
Alt. use	SUZHOU XINKE ELECTRONICS CO LTD	XK-2, XK-3	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E231590

Alt. use	KUNSHAN CITY HUA SHENG CIRCUIT BOARD CO LTD	HS-S	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E229877
Alt. use	HUIZHOU SHUNJIA ELECTRONICS CO LTD	SJ-B	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E320884
Alt. use	SHANGHAI H-FAST ELECTRONICS CO LTD	411001, 211001	Min. 1,6 mm thickness, min. V-0, 130°C	IEC 62368-1 UL 796	Tested with appliance UL E337862
Fuse (FS1, FS2 or F1, F2) (FS2 or F2 is optional) (FS1, FS2 for GT*91099 series, F1, F2 for GT*96600 series, F1 for GT*96600-*56*** series)	Conquer Electronics Co., Ltd.	MST series	T3.15A, 250V	IEC 60127-1 IEC 60127-3 UL 248-1 UL 248-14	VDE 40017118 UL E82636
Alt. use	Ever Island Electric Co., Ltd. And Walter Electric	2010, ICP	T3.15A, 250V	IEC 60127-1 IEC 60127-3 UL 248-1 UL 248-14	VDE 40018781 UL E220181
Alt. use	Bel Fuse Ltd.	RST-Serie(s)	T3.15A, 250V	IEC 60127-1 IEC 60127-3 UL 248-1 UL 248-14	VDE 40011144 UL E20624
Alt. use	Cooper Bussmann LLC	SS-5	T3.15A, 250V	IEC 60127-1 IEC 60127-3 UL 248-1 UL 248-14	VDE 40015513 UL E19180
Alt. use	Shenzhen Lanson Electronics Co. Ltd.	SMT	T3.15A, 250V	IEC 60127-1 IEC 60127-3 UL 248-1 UL 248-14	VDE 40012592 UL E221465
Alt. use	Das & Sons International Ltd.	385T series	T3.15A, 250V	IEC 60127-1 IEC 60127-3 UL 248-1 UL 248-14	VDE 40008524 UL E205718

Alt. use	Dongguan Better Electronics Technology Co., Ltd.	932	T3.15A, 250V	IEC 60127-1 IEC 60127-3 UL 248-1 UL 248-14	VDE 40033369 UL E300003
Alt. use	Hollyland Company Limited	5ET	T3.15A, 250V	IEC 60127-1 IEC 60127-3 UL 248-1 UL 248-14	VDE 40015669 UL E156471
Alt. use	Sunny East Enterprise Co. Ltd.	CFD-Serie(s)	T3.15A, 250V	IEC 60127-1 IEC 60127-3 UL 248-1 UL 248-14	VDE 40030246 UL E133774
Alt. use	Conquer Electronics Co., Ltd.	MET series	T3.15A, 250V	IEC 60127-1 IEC 60127-3 UL 248-1 UL 248-14	VDE 40017157 UL E82636
Alt. use	Zhongshan Lanbao Electrical Appliances Co., Ltd.	RTI-10 Serie(s)	T3.15A, 250V	IEC 60127-1 IEC 60127-3 UL 248-1 UL 248-14	VDE 40017009 UL E213695
Y capacitor (CY1, CY2) (Optional) (CY1 and CY2 for GT*91099 and GT*96600 series; CY1 for GT*96600-*56*** series)	TDK Corporation	CD	Y1, AC250V, max 4700pF, 55/125/21/B	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40017931 UL E37861
Alt. use	Success Electronics Co., Ltd.	SE	Y1, AC250V, or AC500V, max 4700pF, 40/125/56/C	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40037211 VDE 40020002 UL E114280
Alt. use	Success Electronics Co., Ltd.	SB	Y1, AC250V, max 4700pF, 40/125/56/C	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40037221 VDE 40020001 UL E114280
Alt. use	Murata Mfg. Co., Ltd.	KX	Y1, AC250V, max 4700pF, 25/125/21/B	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40002831 UL E37921

Alt. use	Walsin Technology Corp.	AH	Y1, AC250V, max 4700pF, 25/125/21/C	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40001804 UL E146544
Alt. use	JYA-NAY Co., Ltd.	JN	Y1, AC250V, max 4700pF, 25/125/21/C	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40001831 UL E201384
Alt. use	Haohua Electronic Co.	CT 7	Y1, AC250V, max 4700pF, 30/125/56/C	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40003902 UL E233106
Alt. use	Jyh Chung Electronic Co., Ltd.	JD	Y1, AC250V, max 4700pF, 40/125/21/C	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 137027 UL E187963
Alt. use	Jerro Electronics Corp.	JX-series	Y1, AC250V, max 4700pF, 40/125/21/C	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40032158 UL E333001
Alt. use	WELSON INDUSTRIAL CO LT D	WD	Y1, AC250V, max 4700pF, 55/125/21/C	IEC/EN 60384-14	VDE 40016157
X capacitor (CX1) (Optional)	Cheng Tung Industrial Co., Ltd.	CTX	Min. 300VAC, Max. 0.47µF,110 °C, X1 or X2	IEC 62368-1 UL 60384-14 UL 1414	Tested with appliance UL E193049
Alt. use	Tenta Electric Industrial Co. Ltd.	MEX	Min. 250VAC, Max. 0.47µF, 40/100/21/B, X1 or X2	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 119119 UL E222911
Alt. use	Joey Electronics (Dong Guan) Co., Ltd.	MPX	Min. 250VAC, Max. 0.47µF, 40/105/21/B, X1 or X2	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40032481 UL E216807
Alt. use	Ultra Tech Xiphi Enterprise Co. Ltd.	HQX	Min. 250VAC, Max. 0.47µF, 40/100/21/C, X1 or X2	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40015608 UL E183780

Alt. use	Yuon Yu Electronics Co. Ltd.	MPX	Min. 250VAC, Max. 0.47μF, 40/100/21/C, X1 or X2	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40032392 UL E200119
Alt. use	Sinhua Electronics (Huzhou) Co., Ltd.	MPX	Min. 250VAC, Max. 0.47μF, 40/100/21/C, X1 or X2	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40014686 UL E237560
Alt. use	Jiangsu Xinghua Huayu Electronics Co., Ltd.	MPX - Series	Min. 250VAC, Max. 0.47μF, 40/100/21/C, X1 or X2	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40022417 UL E311166
Alt. use	Dain Electronics Co., Ltd.	MEX, MPX, NPX	Min. 250VAC, Max. 0.47μF, 40/100/21/C, X1 or X2	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40018798 UL E147776
Alt. use	Shenzhen Jinghao Capacitor Co., Ltd.	CBB62B	Min. 250VAC, Max. 0.47μF, 40/110/56/B, X1 or X2	IEC/EN 60384-14 UL 60384-14 UL 1414	VDE 40018690 UL E252286
Alt. use	Foshan Shunde Chuang Ge Electronic Industrial Co., Ltd.	MKP-X2	Min. 250VAC, Max. 0.47μF, 40/105/21/B, X2	IEC/EN 60384-14	VDE 40008922
Alt. use	Okaya Electric Industries Co. LTD	RE-Series	Min. 250VAC, Max. 0.47μF, 55/100/56/C, X2	IEC/EN 60384-14	VDE 40028657
Alt. use	VISHAY Capacitors Belgium NV	F 1772	Min. 250VAC, Max. 0.47μF, 40/100/56/C, X2	IEC/EN 60384-14	VDE 40005095
Alt. use	Winday Electronic Industrial Co., Ltd.	MPX series	Min. 250VAC, Max. 0.47μF, 40/100/21/C, X2	IEC/EN 60384-14	VDE 40018071
Photo coupler (U1 or U4) (U1 for GT*91099 series, U4 for GT*96600 series, U1 For GT*96600-*56*** series)	Everlight Electronics Co., Ltd.	EL817	Dti=0.5mm Int. , dcr=6.0mm EXT.dcr=7.7mm, thermal cycling test,110°C	IEC/EN 60747-5-2	VDE 132249

Alt. use	COSMO Electronics Corporation	K1010 / KP1010	Dti=0.6mm Int. , dcr=4.0mm EXT.dcr=5.0mm, thermal cycling test,115°C	IEC/EN 60747-5-2	VDE 101347
Alt. use	Lite-On Technology Corporation	LTV-817	Dti=0.8mm Int. , EXT.dcr=7.8mm, thermal cycling test,100°C	IEC/EN 60747-5-2	VDE 40015248
Alt. use	Fairchild Semiconductor Pte Ltd.	H11A817B / FOD817B	Insulation voltage: 850V; Transient overvoltage: 6000V; CTI175; Int. Cr/ Ext. Cr: ≥7,0/ 7,0 mm; 30/110/21	IEC/EN 60747-5-2	VDE 40026857
Alt. use	Sharp Corporation Electronic Components and Devices Group	PC817	Insulation voltage: 890V; Transient overvoltage: 9000V Int. Cr/ Ext. Cr: 7.62/ 7.62 mm; 30/100/21	IEC/EN 60747-5-2	VDE 40008087
Alt. use	Bright Led Electronics Corp.	BPC-817 A/B/C/D/L BPC-817 M BPC-817 S	Dti=0.4mm EXT.dcr=7.0mm, thermal cycling test,100°C	IEC/EN 60747-5-2	VDE 40007240
Alt. use	Toshiba Corporation Semiconductor & Storage Products Company	TLP817F	Dti > 0.4mm, Ext cr > 8.0mm, Isolation 3000Vac min., 110°C min., Thermal cycling test	IEC/EN 60747-5-2	VDE 40021173
Varistor MOV1 or MOV (Optional) (MOV/MOV1 for GT*91099 series, MOV1 for GT*96600 series and GT*96600-*56*** series)	Thinking Electronic Industrial Co., Ltd.	TVR10471K, TVR14471K	Max. Continuous voltage: min 300Vac(rms), 85°C, The coating is V-0	IEC 61051-1 IEC 61051-2 IEC 61051-2-2 Annex Q of IEC 60950-1	VDE 005944

Alt. use	Centra Science Corp.	10D471K, 14D471K	Max. Continuous voltage: min 300Vac(rms), 85°C, The coating is V-0	IEC 61051-1 IEC 61051-2 IEC 61051-2-2 Annex Q of IEC 60950-1	VDE 4008220
Alt. use	Success Electronics Co., Ltd.	SVR10D471K SVR14D471K	Max. Continuous voltage: min 300Vac(rms), 85°C, The coating is V-0	IEC 61051-1 IEC 61051-2 IEC 61051-2-2 Annex Q of IEC 60950-1	VDE 40030401
Alt. use	Walsin Technology Co., Ltd.	14D471K 10D471K	Max. Continuous voltage: min 300Vac(rms), 85°C, The coating is V-0	IEC 61051-1 IEC 61051-2 IEC 61051-2-2 Annex Q of IEC 60950-1	VDE 40010090
Alt. use	Lien Shun Electronics Co., Ltd.	14D471K 10D471K	Max. Continuous voltage: min 300Vac(rms), 85°C, The coating is V-0	IEC 61051-1 IEC 61051-2 IEC 61051-2-2 Annex Q of IEC 60950-1	VDE 40005858
Alt. use	Ceramate Techn. Co., Ltd.	GNR10D471K GNR14D471K	Max. Continuous voltage: min 300Vac(rms), 85°C, The coating is V-0	IEC 61051-1 IEC 61051-2 IEC 61051-2-2 Annex Q of IEC 60950-1	VDE 40031745
Alt. use	Brightking (Shenzhen) Co., Ltd.	14D471K 10D471K	Max. Continuous voltage: min 300Vac(rms), 85°C, The coating is V-0	IEC 61051-1 IEC 61051-2 IEC 61051-2-2 Annex Q of IEC 60950-1	VDE 40027827
Alt. use	Joyin Co., Ltd.	JVR10N471K JVR14N471K	Max. Continuous voltage: min 300Vac(rms), 85°C, The coating is V-0	IEC 61051-1 IEC 61051-2 IEC 61051-2-2 Annex Q of IEC 60950-1	VDE 005937
Appliance inlet CN1 Class I units(C6 type)	Zhejiang LECI Electronics Co., Ltd.	DB-6	2.5A, 250Vac	IEC/EN 60320-1	VDE 40032465
Alt. use	Rich Bay Co., Ltd.	R-30790	2.5A, 250Vac	IEC/EN 60320-1	VDE 40030381

Alt. use	Sun Fair Electric Wire & Cable (HK) Co. Ltd.	S-02	2.5A, 250Vac	IEC/EN 60320-1	VDE 40034448
Alt. use	TECX-UNIONS Technology Corporation	TU-333	2.5A, 250Vac	IEC/EN 60320-1	ENEC 00633
Alt. use	Rong Feng Industrial Co., Ltd.	RF-190	2.5A, 250Vac	IEC/EN 60320-1	VDE 40030379
Alt. use	Inalways Corporation	0724	2.5A, 250Vac	IEC/EN 60320-1	ENEC 2010080
Alt. use	Zhe Jiang Bei Er jia	ST-A04-002	2.5A, 250Vac	IEC/EN 60320-1	VDE 40016045
Alt. use	Shenzhen Delikang Electronics Technology Co. Ltd.	CDJ-2	2.5A, 250Vac	IEC/EN 60320-1	VDE 40015580
Appliance inlet CN1 Class I units (C14 type)	Zhejiang LECI Electronics Co., Ltd.	DB-14	10A, 250Vac	IEC/EN 60320-1	VDE 40032137
Alt. use	Rich Bay Co., Ltd.	R-301SN	10A, 250Vac	IEC/EN 60320-1	VDE 40030228
Alt. use	Sun Fair Electric Wire & Cable (HK)Co. Ltd.	S-03	10A, 250Vac	IEC/EN 60320-1	VDE 40034447
Alt. use	TECX-UNIONS Technology Corporation	TU-301-S, TU-301-SP	10A, 250Vac	IEC/EN 60320-1	ENEC 00647
Alt. use	Rong Feng Industrial Co., Ltd.	SS-120	10A, 250Vac	IEC/EN 60320-1	VDE 40028101
Alt. use	Inalways Corporation	0711	10A, 250Vac	IEC/EN 60320-1	ENEC 2010084
Alt. use	Zhe Jiang Bei Er jia	ST-A01-003J	10A, 250Vac	IEC/EN 60320-1	VDE 40013388
Appliance inlet CN1 Class II units (C8 type)	Zhejiang LECI Electronics Co., Ltd.	DB-8	2.5A, 250Vac	IEC/EN 60320-1	VDE 40032028
Alt. use	Rich Bay Co., Ltd.	R-201SN90	2.5A, 250Vac	IEC/EN 60320-1	VDE 40030384
Alt. use	Sun Fair Electric Wire & Cable (HK)Co. Ltd.	S-01	2.5A, 250Vac	IEC/EN 60320-1	VDE 40034449

Alt. use	TECX-UNIONS Technology Corporation	SO-222	2.5A, 250Vac	IEC/EN 60320-1	VDE 40043268
Alt. use	Rong Feng Industrial Co., Ltd.	RF-180	2.5A, 250Vac	IEC/EN 60320-1	VDE 40030168
Alt. use	Inalways Corporation	0721	2.5A, 250Vac	IEC/EN 60320-1	ENEC 2010087
Alt. use	Zhe Jiang Bei Er jia	ST-A03-005	2.5A, 250Vac	IEC/EN 60320-1	VDE 40014833
Alt. use	Shenzhen Delikang Electronics Technology Co. Ltd.	CDJ-8	2.5A, 250Vac	IEC/EN 60320-1	VDE 40025531
Appliance inlet CON1 Class II units (C18 type)	HCR ELECTRONICS CO., LTD	SK05	10A, 250Vac	IEC/EN 60320-1	ENEC (NO4018)
Alt. use	Rong Feng Industrial Co., Ltd.	SS-120	10A, 250Vac	IEC/EN 60320-1	VDE 40028101
Input connector CN1 (For open frame)	NELTRON INDUSTRIAL CO LTD	2114S	Min 240V; Min 1.5A; Flame class min. V-2;	IEC/EN 62368-1	Tested with appliance UL E144392
Alt. use	JOINT TECH ELECTRONIC INDUSTRIAL CO LTD	A7920 series A3960 series	Min 250V; Min 7A; Flame class min. V-2;	IEC/EN 62368-1	Tested with appliance UL E179987
Alt. use	ZHEJIANG HONGXING ELECTRICAL CO LTD	HX396XX-YYY series	Min 250V; Min 5A; Flame class min. V-2;	IEC/EN 62368-1	Tested with appliance UL E228500
Earthing wire for Class I model	KUNSHAN NEW ZHICHENG ELECTRONICS TECHNOLOGIES CO LTD	1015,1007, 1185, 3271, 3266, 1569	Min. 20 AWG, Min. 300V, Min. 80°C	IEC/EN 62368-1	Tested with appliance UL E237831
Alt. use	ZHUANG SHAN CHUAN ELECTRICAL PRODUCTS (KUNSHAN) CO LTD	1015,1007, 1185,1569	Min. 20 AWG, Min. 300V, Min. 80°C	IEC/EN 62368-1	Tested with appliance UL E333601
Alt. use	DONGGUAN CHUANTAI WIRE PRODUCTS CO LTD	1015,1007, 1185,1569	Min. 20 AWG, Min. 300V, Min. 80°C	IEC/EN 62368-1	Tested with appliance UL E315628

Alt. use	YONG HAO ELECTRICAL INDUSTRY CO LTD	1015,1007, 1185,1569	Min. 20 AWG, Min. 300V, Min. 80°C	IEC/EN 62368-1	Tested with appliance UL E240426
Alt. use	DONGGUAN GUNEETAL WIRE & CABLE CO LTD	1015,1007, 1185, 3271, 3266, 1569	Min. 20 AWG, Min. 300V, Min. 80°C	IEC/EN 62368-1	Tested with appliance UL E204204
Alt. use	SHENG YU ENTERPRISE CO LTD	1015, 1007, 1185	Min. 20 AWG, Min. 300V, Min. 80°C	IEC/EN 62368-1	Tested with appliance UL E219726
Alt. use	KUNSHAN XINGHONGMENG ELECTRONIC CO LTD	1015,1007, 1185, 3271, 3266, 1569	Min. 20 AWG, Min. 300V, Min. 80°C	IEC/EN 62368-1	Tested with appliance UL E315421
Alt. use	SUZHOU YEMAO ELECTRONIC CO LTD	1015, 1007, 1185	Min. 20 AWG, Min. 300V, Min. 80°C	IEC/EN 62368-1	Tested with appliance UL E353532
Connection wiring for encapsulated models	KUNSHAN NEW ZHICHENG ELECTRONICS TECHNOLOGIES CO LTD	1015, 1007, 2468, 2464, 1185	Min. 20 AWG, Min. 300V, Min. 80°C	IEC/EN 62368-1	Tested with appliance UL E237831
Alt. use	Interchangeable	1015, 1007, 2468, 2464, 1185, SPT-1, SPT-2	Min. 20AWG, min. 300Vac, min. 80°C	IEC/EN 62368-1 UL 758	Tested with appliance UL approved
- Description:	Interchangeability based on specified rating.				
Output cord	Interchangeable	Interchangeable	Min. 24AWG, min. 300Vac, min. 80°C	IEC/EN 62368-1 UL 758	Tested with appliance UL approved
- Description:	Interchangeability based on specified rating.				
Bridge diode (BD1)	Interchangeable	Interchangeable	Min. 4A, Min. 600V, Size: 19.0x6.2x15.0mm	IEC/EN 62368-1	Tested with appliance UL approved
- Description:	Interchangeability based on specified dimensions due to mounting (including connections) and specified rating				
Heat-shrinkable tubing (Optional)	SHENZHEN WOER HEAT-SHRINKABLE MATERIAL CO LTD	RSFR, RSFR-H, RSFR-HPF	600V, 125°C	IEC/EN 62368-1	Tested with appliance UL E203950

Alt. use	QIFURUI ELECTRONICS CO	QFR-h	600V, 125°C	IEC/EN 62368-1 UL 224	Tested within appliance UL E225897
Alt. use	DONGGUAN SALIPT CO LTD	SALIPT S-901-300 SALIPT S-901-600	Min. 300V, 125°C	IEC/EN 62368-1 UL 224	Tested within appliance UL E209436
Alt. use	GUANGZHOU KAIHENG ENTERPRISE GROUP	K-2 (+) K-2 (CB)	Min. 300V, 125°C	IEC/EN 62368-1 UL 224	Tested within appliance UL E214175
Alt. use	CHANGYUAN ELECTRONICS (SHENZHEN) CO LTD	CB-HFT	Min. 300V, 125°C	IEC/EN 62368-1 UL 224	Tested within appliance UL E180908
Electrolytic capacitor (C1, C3) (C1 for GT*91099 and GT*96600 series; C3 for GT*96600-*56*** series)	Interchangeable	Interchangeable	Min. 68uF, 400V, Size: 18mm diameter; 35mm length	IEC/EN 62368-1	Tested with appliance
- Description:	Interchangeability based on specified dimensions due to mounting (including connections) and specified rating.				
Line filter LF1	GlobTek/HAOPUWEI/HEJIA	GTM91099-LF1 or LF019	Min. 200uH	IEC/EN 62368-1	Tested with appliance
Line filter LF2	GlobTek/HAOPUWEI/HEJIA	NF00031	Min. 10mH	IEC/EN 62368-1	Tested with appliance
Transformer (T1)	GlobTek / ENG / BOAM / HAOPUWEI	See attachment for details	Class B, with critical component listed below	IEC 62368-1	Tested with appliance
- Magnet wire	PACIFIC ELECTRIC WIRE & CABLE (SHENZHEN) CO LTD	UEWN/U (UL E201757)	MW28-C, 130°C	IEC 62368-1	Tested with appliance
Alt. use	PACIFIC ELECTRIC WIRE & CABLE (SHENZHEN) CO LTD	UEWS/U (UL E201757)	MW75-C, 130°C	IEC 62368-1	Tested with appliance
Alt. use	JUNG SHING WIRE CO LTD	UEW-4 (UL E174837)	MW75C, 130°C	IEC 62368-1	Tested with appliance
Alt. use	JUNG SHING WIRE CO LTD	UEY-2 (UL E174837)	MW28-C, 130°C	IEC 62368-1	Tested with appliance

Alt. use	JIANGSU HONGLIU MAGNET WIRE TECHNOLOGY CO LTD	2UEW/130 (UL E335065)	MW75-C, 130°C	IEC 62368-1	Tested with appliance
Alt. use	CHANGZHOU DAYANG WIRE & CABLE CO LTD	2UEW/130 (UL E158909)	MW75-C, 130°C	IEC 62368-1	Tested with appliance
Alt. use	WUXI JUFENG COMPOUND LINE CO LTD	2UEWB (UL E206882)	MW75#, 130°C	IEC 62368-1	Tested with appliance
Alt. use	JIANGSU DARTONG M & E CO LTD	UEW (UL E237377)	MW 75-C, 130°C	IEC 62368-1	Tested with appliance
Alt. use	SHANDONG SAINT ELECTRIC CO LTD	UEW/130 (UL E194410)	MW75#, 130°C	IEC 62368-1	Tested with appliance
Alt. use	ZHEJIANG LANGLI ELECTRIC EQUIPMENTS CO LTD	UEW (UL E222214)	MW 79#, 130°C	IEC 62368-1	Tested with appliance
Alt. use	NINGBO JINTIAN NEW MATERIAL CO LTD	2UEW/130 (UL E227047)	MW 75-C, 130°C	IEC 62368-1	Tested with appliance
-Triple-insulated wire (Secondary)	Great Leoflon Industrial Co., Ltd.	TRW (B) Serie(s)	Class B, reinforced insulation	IEC 62368-1 UL 2353 UL 60601-1	VDE 136581 UL E211989
- Alt. use	COSMOLINK CO. Ltd.	TIW-M Serie(s)	Class B, reinforced insulation	IEC 62368-1 UL 2353 UL 60601-1	VDE 138053 UL E213764
- Alt. use	Furukawa Electric Co., Ltd. Electronics & Automotive Systems Company Global Business Development Division	TEX-E	Class B, reinforced insulation	IEC 62368-1 UL 2353 UL 60601-1	VDE 006735 UL E206440
- Alt. use	TOTOKU ELECTRIC CO LTD	TIW-2	Reinforced insulation, rated 130° C (Class B)	IEC 62368-1 UL 2353 UL 60601-1	VDE 40005152 UL E249037

- Alt. use	E&B TECHNOLOGY CO LTD	E&B-XXXB E&B-XXXB-1	Reinforced insulation, Class B	IEC 62368-1 UL 2353 UL 60601-1	VDE 40023473 UL E315265
- Alt. use	CHANGYUAN ELECTRONICS (SHENZHEN) CO LTD	CB-TIW	Reinforced insulation, Class B	IEC 62368-1 UL 2353 UL 60601-1	Tested with appliance UL E249037
- Alt. use	SHENZHEN JIUDING NEW MATERIAL CO LTD	DTIW-B	Reinforced insulation, Class B	IEC 62368-1 UL 2353 UL 60601-1	VDE 40037495 UL E357999
-Bobbin	CHANG CHUN PLASTICS CO LTD	T375J T375HF	V-0, 150°C, thickness 0,45 mm min.	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E59481
- Alt. use	CHANG CHUN PLASTICS CO LTD	4130	V-0, 140°C, thickness 0,74 mm min.	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E59481
- Alt. use	SUMITOMO BAKELITE CO LTD	PM-9820	V-0, 150°C, thickness 0,45 mm min.	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E41429
- Alt. use	HITACHI CHEMICAL CO LTD	CP-J-8800	V-0, 150°C, thickness 0,45 mm min.	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E42956
-Insulating tape	3M COMPANY ELECTRICAL MARKETS DIV (EMD)	1350F-1 1350T-1 44	Min.130°C	IEC 62368-1 UL 510	Tested with appliance UL E17385
- Alt. use	BONDTEC PACIFIC CO LTD	370S	Min.130°C	IEC 62368-1 UL 510	Tested with appliance UL E175868
- Alt. use	JINGJIANG YAHUA PRESSURE SENSITIVE GLUE CO LTD	PZ CT WF	Min.130°C	IEC 62368-1 UL 510	Tested with appliance UL E165111
- Alt. use	JINGJIANG JINGYI ADHESIVE PRODUCT CO LTD	JY25-A	Min.130°C	IEC 62368-1 UL 510	Tested with appliance UL E246950

- Alt. use	CHANG SHU LIANG YI TAPE INDUSTRY CO LTD	LY-XX	Min.130°C	IEC 62368-1 UL 510	Tested with appliance UL E246820
-PTFE tubing	GREAT HOLDING INDUSTRIAL CO LTD	TFT / TFS	Min. 300V, 200°C	IEC 62368-1	Tested with appliance UL E156256
-Alt. use	SHENZHEN WOER HEAT-SHRINKABLE MATERIAL CO LTD	WF	600V, 200°C	IEC 62368-1	Tested with appliance UL E203950
-Alt. use	CHANGYUAN ELECTRONICS (SHENZHEN) CO LTD	CB-TT-T / CB-TT-S	Min. 300V, 200°C	IEC 62368-1	Tested with appliance UL E180908
Enclosure (all parts)	SABIC INNOVATIVE PLASTICS B V	C2950	PC/ABS, Min. V-0, Min. thickness: 2.0mm, 85°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E45329
Alt. use	SABIC INNOVATIVE PLASTICS B V	HF500R	PC, V-0, Min. thickness: 2.0mm, 125°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E45329
Alt. use	SABIC INNOVATIVE PLASTICS B V	CX7211 EXCY0098	PC/ABS, Min. V-0, Min. thickness: 2.0mm, 90°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E45329
Alt. use	SABIC INNOVATIVE PLASTICS B V	945 940	PC, Min. V-1, Min. thickness: 2.0mm, 120°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E45329
Alt. use	SABIC INNOVATIVE PLASTICS B V	SE1, SE1X	PPE+PS, Min. V-1, Min. thickness:2.0mm, 105°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E45329
Alt. use	SABIC INNOVATIVE PLASTICS B V	SE100	PPE+PS, Min. V-1, Min. thickness:2.0mm, 95°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E45329
Alt. use	SABIC JAPAN L L C	C2950	PC/ABS, Min. V-0, Min. thickness: 2.0mm, 105°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E207780

Alt. use	SABIC JAPAN L L C	CX7211 EXCY0098	PC/ABS, Min. V-1, Min. thickness: 2.0mm, 90°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E207780
Alt. use	SABIC JAPAN L L C	945 940	PC, Min. V-1, Min. thickness: 2.0mm, 120°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E207780
Alt. use	SABIC JAPAN L L C	HF500R	PC, V-0, Min. thickness: 2.0mm, 125°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E207780
Alt. use	SABIC JAPAN L L C	SE1, SE1X	PPE+PS, Min. V-1, Min. thickness:2.0mm, 105°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E207780
Alt. use	SABIC JAPAN L L C	SE100	PPE+PS, Min. V-1, Min. thickness:2.0mm, 95°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E207780
Alt. use	TEIJIN CHEMICALS LTD	LN-1250P LN-1250G	PC, Min. V-0, Min. thickness: 2.0mm, 115°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E50075
Alt. use	CHI MEI CORPORATION	PA-765A	ABS, Min. V-0, Min. thickness: 2.0mm, 85°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E56070
Alt. use	CHI MEI CORPORATION	PC-540	PC/ABS, Min. V-0, Min. thickness: 2.0mm, 70°C	IEC 62368-1 UL 94 UL 746 A/B/C/D	Tested with appliance UL E56070

End of Test Report